

# Statistics & Probability in Mechanical Design

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Monday, March 12<sup>th</sup>, 2012



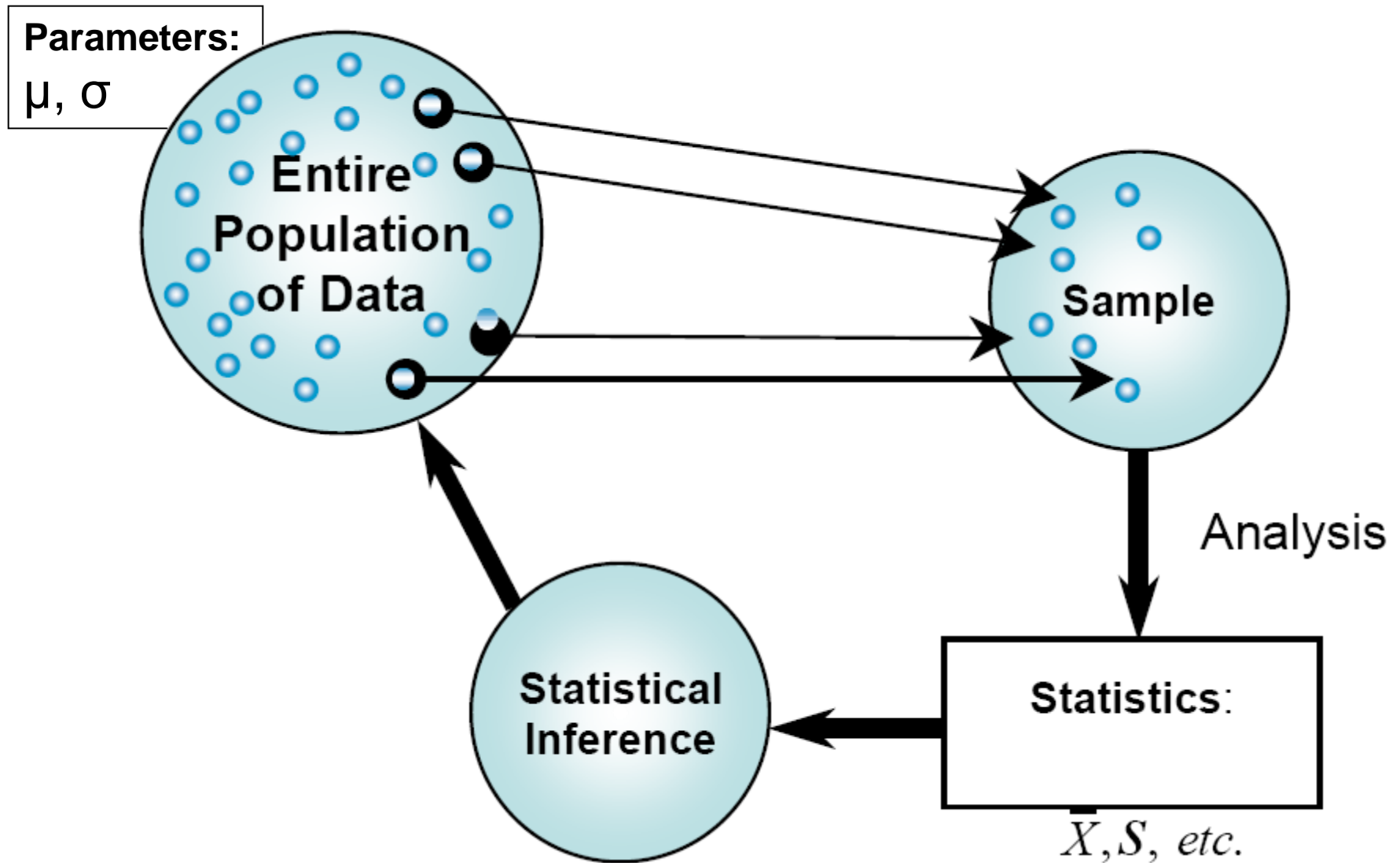
# Why Statistical Methods

- Disciplined Approach
- Repeatable Results
- Quantifiable Decision Criteria
- Optimization

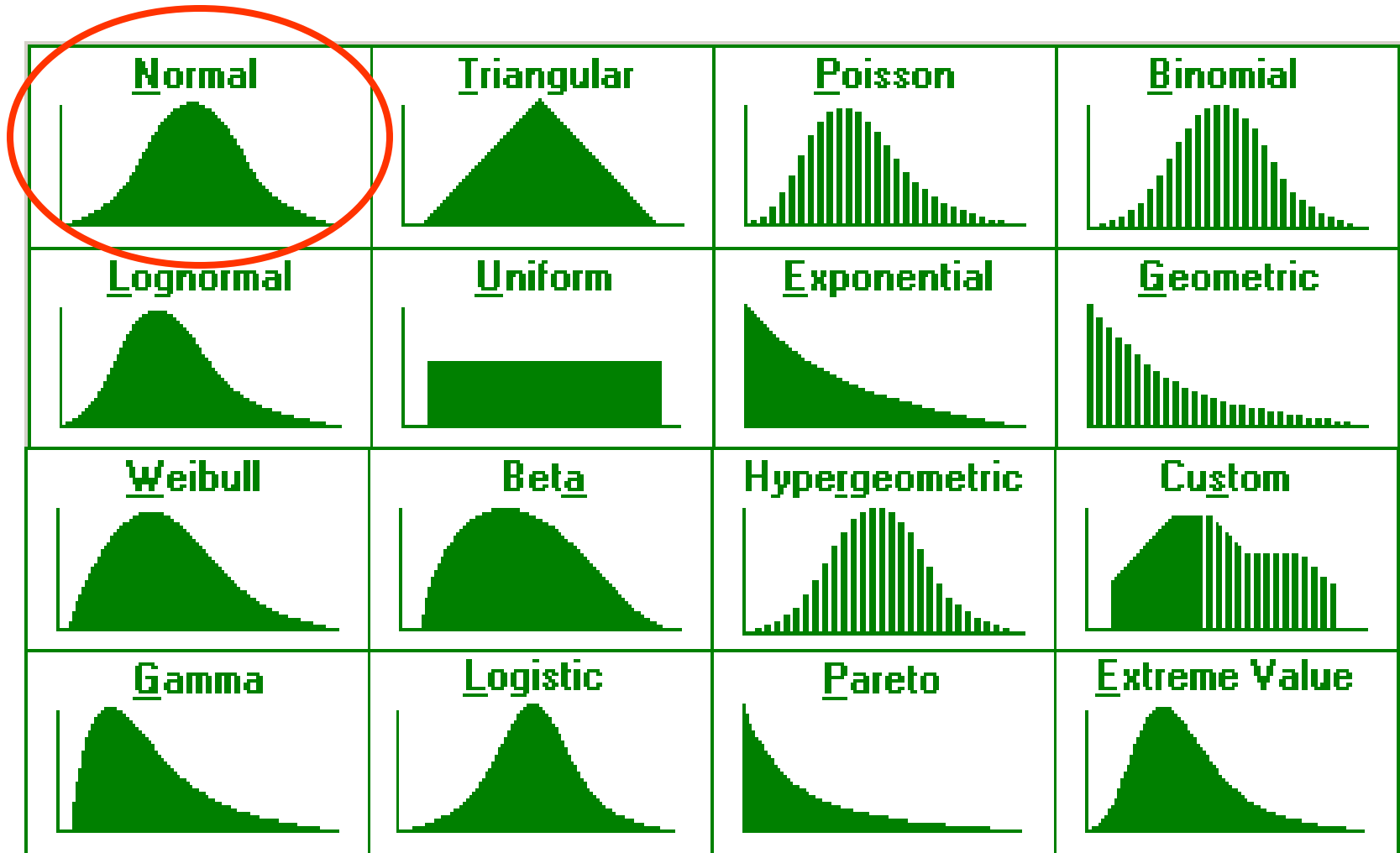


# **Statistics Review**

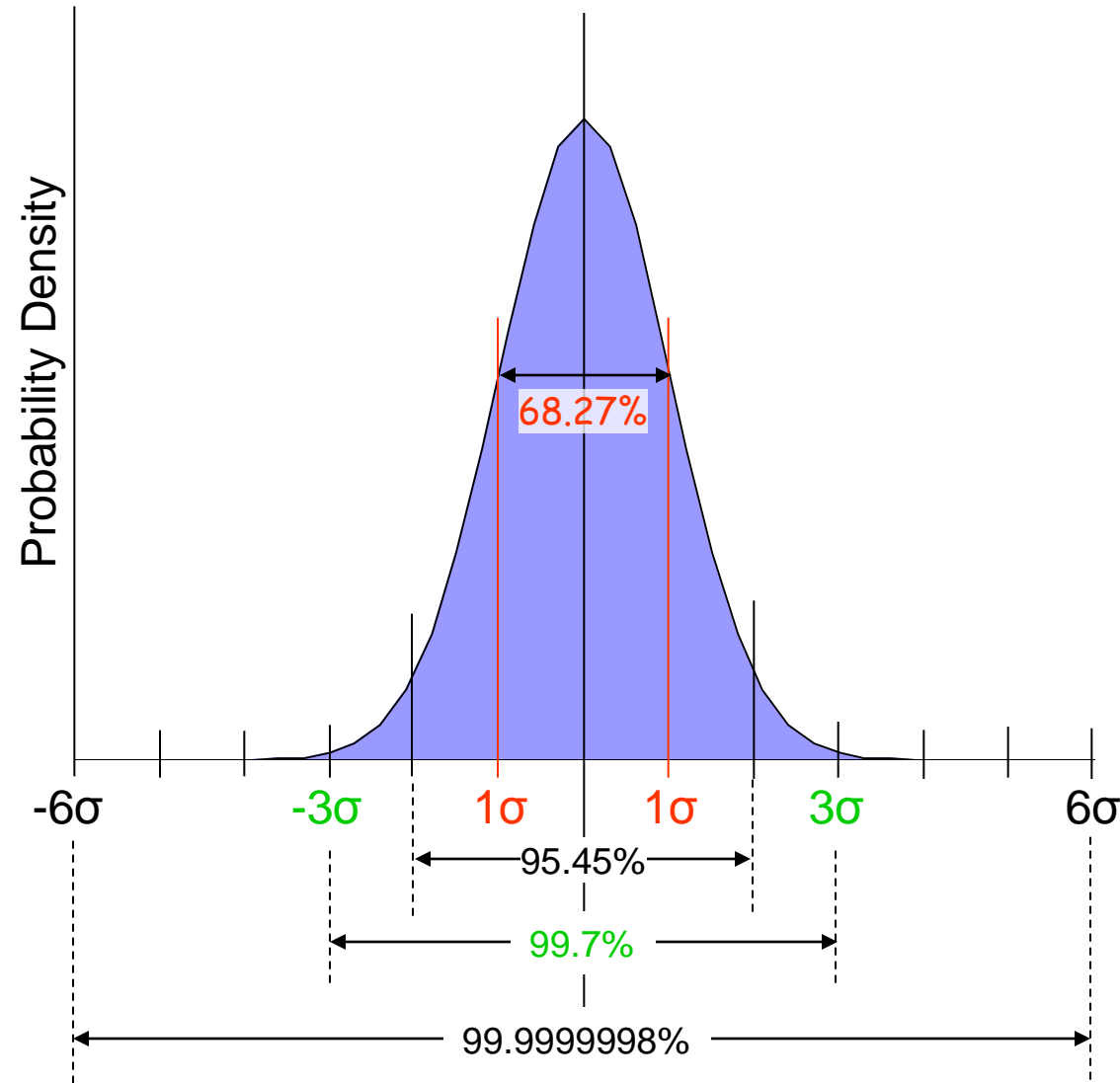
# Population Sampling



# Probability Distributions



# Normal Distribution



$$f(x) = \frac{e^{-(x-\mu)^2 / (2\sigma^2)}}{\sigma(2\pi)^{1/2}}$$

$\mu$  = mean

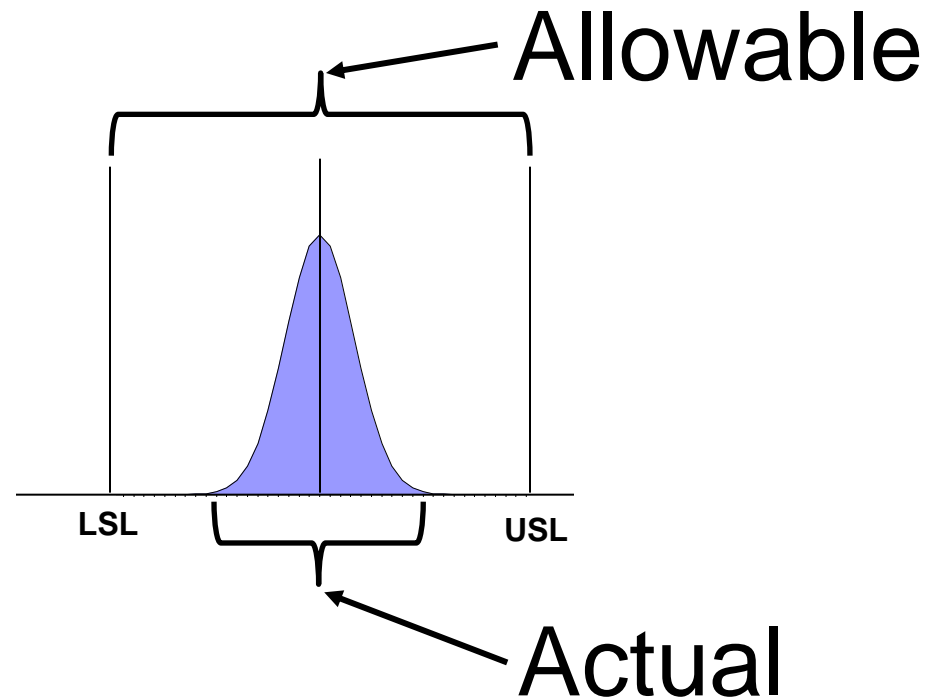
$\sigma$  = standard deviation

# Process Capability

# Normal Distribution

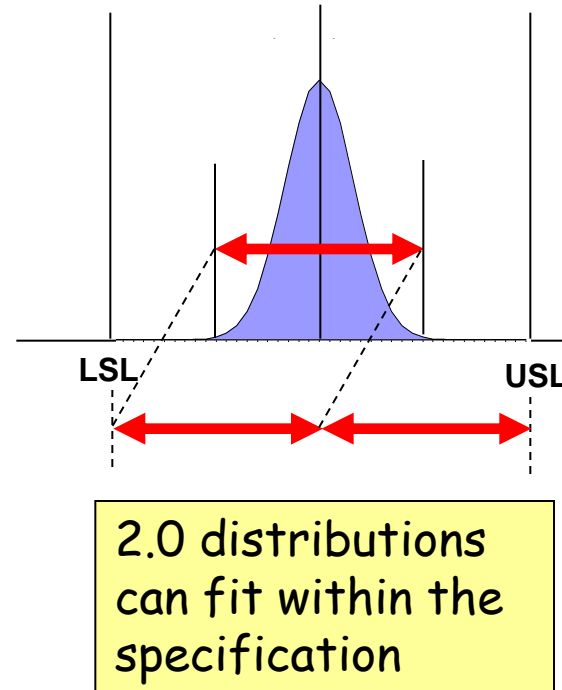
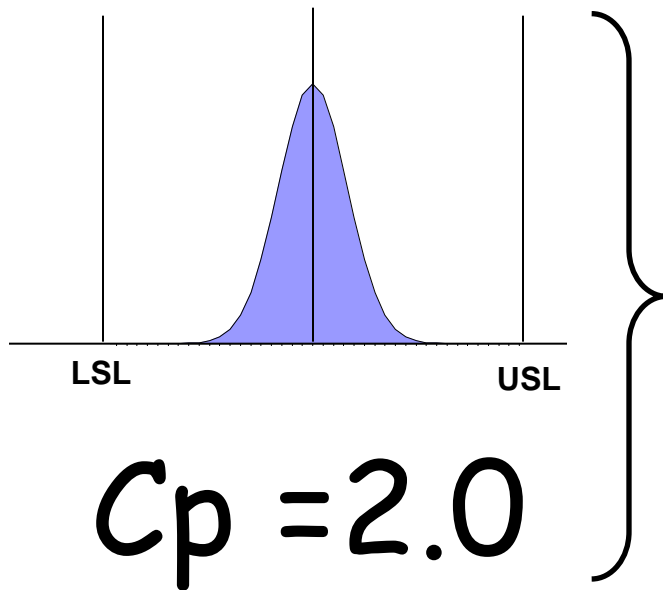
$$C_p = \frac{\text{Allowable Variation}}{\text{Actual Variation}}$$

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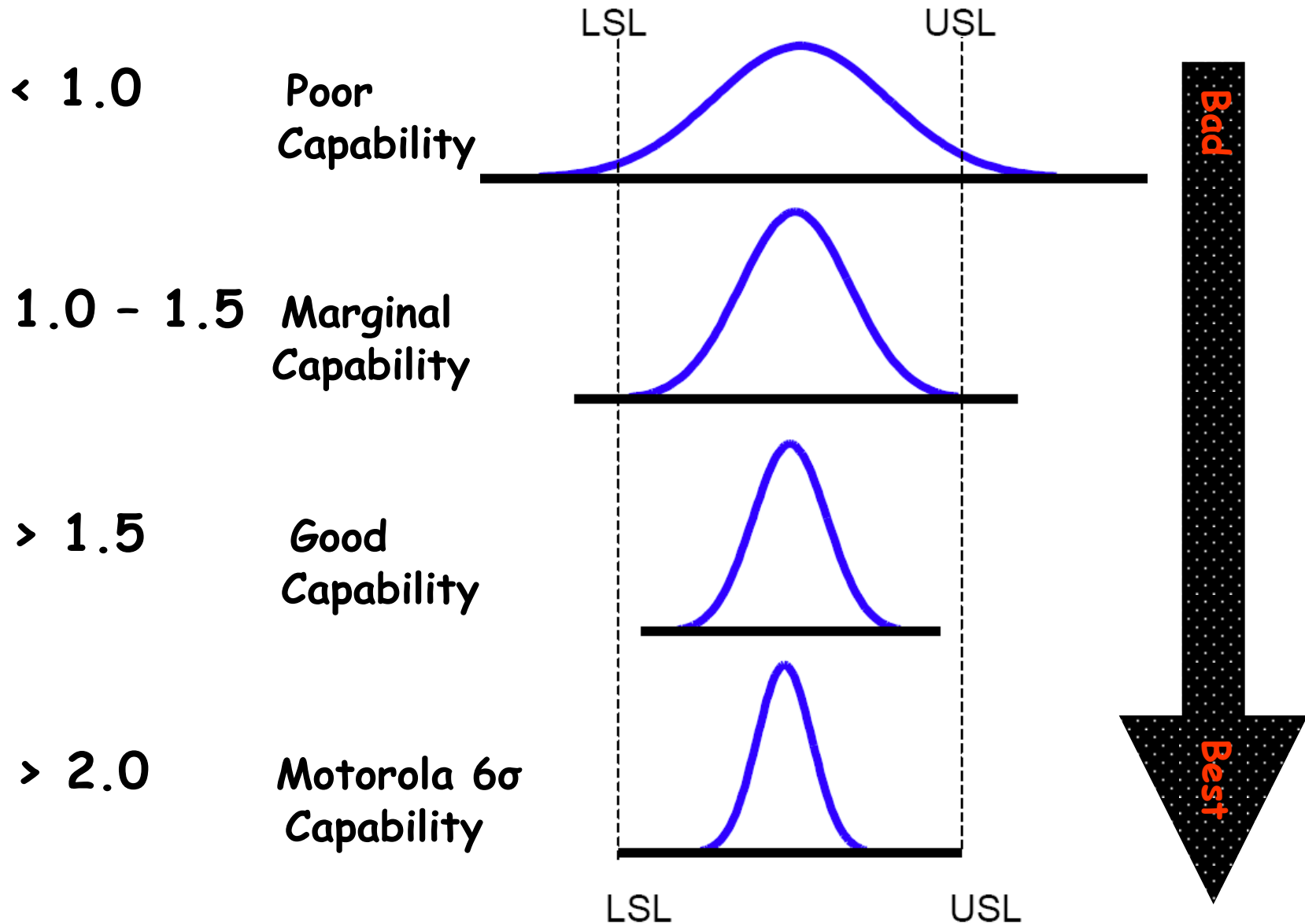




# Process Capability

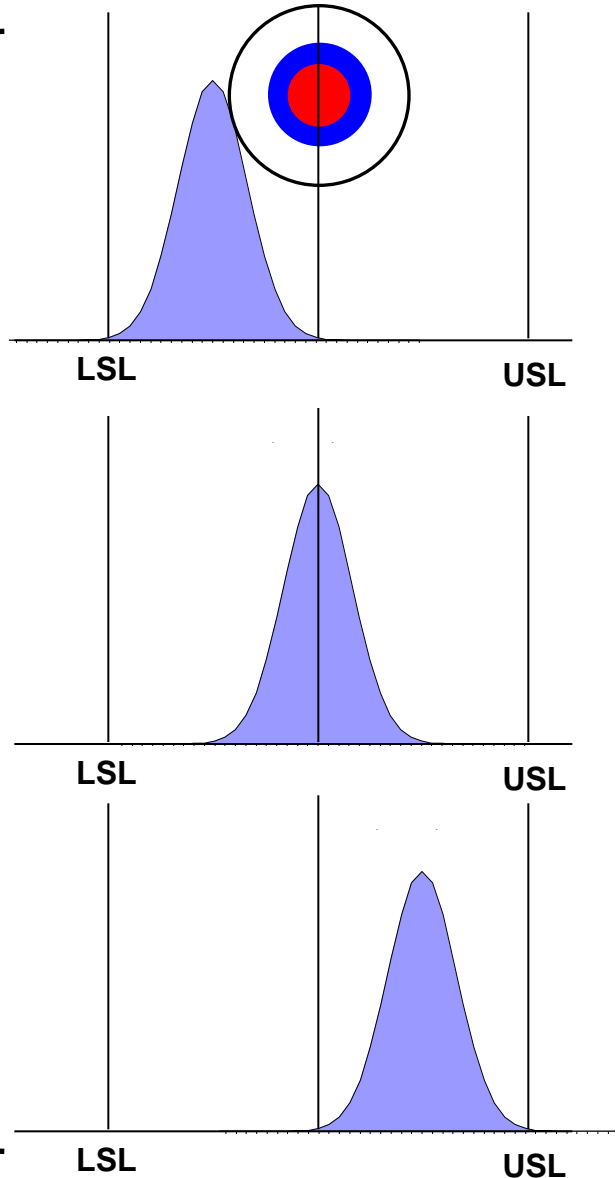


# Process Capability



# Process Capability

$$C_p = 2.0$$



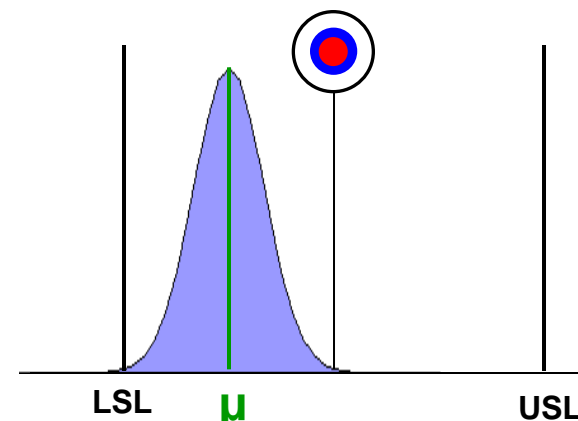
$C_p$   
Independent  
of the  
  
target.



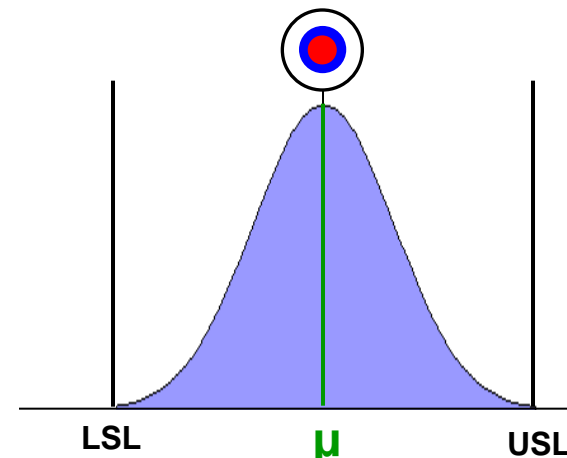
# Process Capability; Cp & Cpk

$$C_p = \frac{USL - LSL}{6\sigma}$$

$$C_{pk} = \min \left[ \frac{USL - \mu}{3\sigma}, \frac{\mu - LSL}{3\sigma} \right]$$



$C_p = 2.0$   
 $C_{pk} = 1.0$



$C_p = 1.0$   
 $C_{pk} = 1.0$



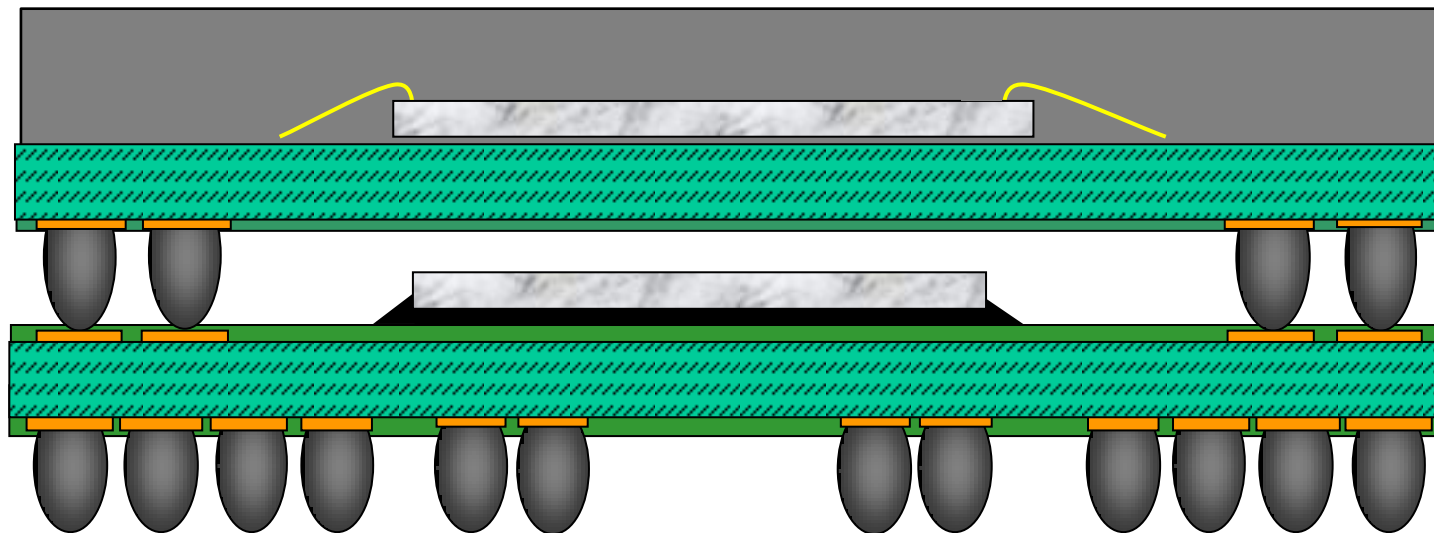
# Cp, Cpk Example

**Chip set Stack Up**

**THINNER**



# Chipset Stack Up



## Package Height Prediction (post-reflow)

Memory Mold Cap (2-die)

Memory Substrate Thk.

Memory Ball Ht. (after reflow)

OMAP Mold Cap (Ref.)

OMAP / W3G Die Thickness (um)

Die-to-Substrate Gap (um)

OMAP Top Ball Ht.

OMAP/W3G Substrate Thk. (w/o SM)

OMAP/W3G Ball Ht. (after reflow)

OMAP/W3G Ball Ht. (before reflow)

Total 2-Package POP Height (post-reflow):

Max. 2-Package POP Height (post-reflow):

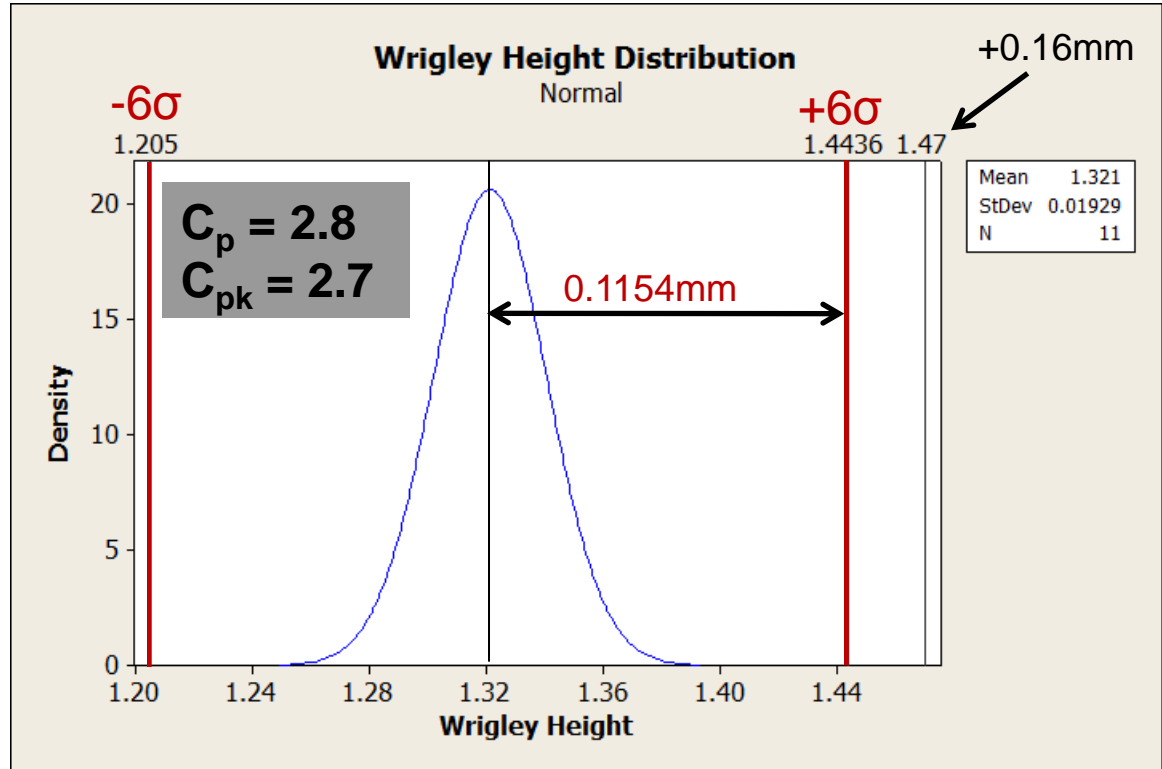
	W3G (current)			
	Min.	Nom.	Max.	Tol.
Memory Mold Cap (2-die)	0.330	0.340	0.350	0.010
Memory Substrate Thk.	0.110	0.140	0.170	0.030
Memory Ball Ht. (after reflow)	0.140	0.190	0.240	0.050
OMAP Mold Cap (Ref.)	0.000	0.000	0.000	0.000
OMAP / W3G Die Thickness (um)	0.095	0.100	0.105	0.005
Die-to-Substrate Gap (um)	0.020	0.025	0.030	0.005
OMAP Top Ball Ht.	0.000	0.000	0.000	0.000
OMAP/W3G Substrate Thk. (w/o SM)	0.408	0.448	0.488	0.040
OMAP/W3G Ball Ht. (after reflow)	0.168	0.206	0.244	0.038
OMAP/W3G Ball Ht. (before reflow)	0.180	0.230	0.280	0.050
Total 2-Package POP Height (post-reflow):	1.24	1.32	1.40	
Max. 2-Package POP Height (post-reflow):		1.40	RSS:	0.081



# Chipset Height Cp, Cpk

Current Stack Up	
Wrigley	1.31
Gap	0.16
Shield	0.13
<b>Total</b>	<b>1.60</b>

Proposed Stack Up	
Wrigley	1.31
Gap	0.12
Shield	0.10
<b>Total</b>	<b>1.53</b>



Etna

Targa



Program	Supplier	Part_Num	Point_1(mm)	Point_2(mm)	Point_3(mm)	Point_4(mm)
Etna	hynix - 031A	1	1.318	1.325	1.306	1.298
Etna	hynix - 920A	2	1.319	1.321	1.304	1.294
Etna	hynix - 920A	3	1.293	1.325	1.292	1.300
Etna	hynix - 920A	6	1.294	1.305	1.279	1.361
Etna	hynix - 046A	7	1.307	1.337	1.316	1.315
Etna	hynix - 046A	8	1.365	1.368	1.358	1.347
Targa	hynix - LV57908	A2-1	1.348	1.345	1.347	1.357
Targa	hynix - LV57908	A5-2	1.330	1.340	1.334	1.338
Targa	hynix - LV57908	B3-3	1.287	1.315	1.292	1.297
Targa	hynix - LV57908	B6-4	1.319	1.330	1.318	1.322
Targa	hynix - LV57908	C1-5	1.321	1.323	1.312	1.318



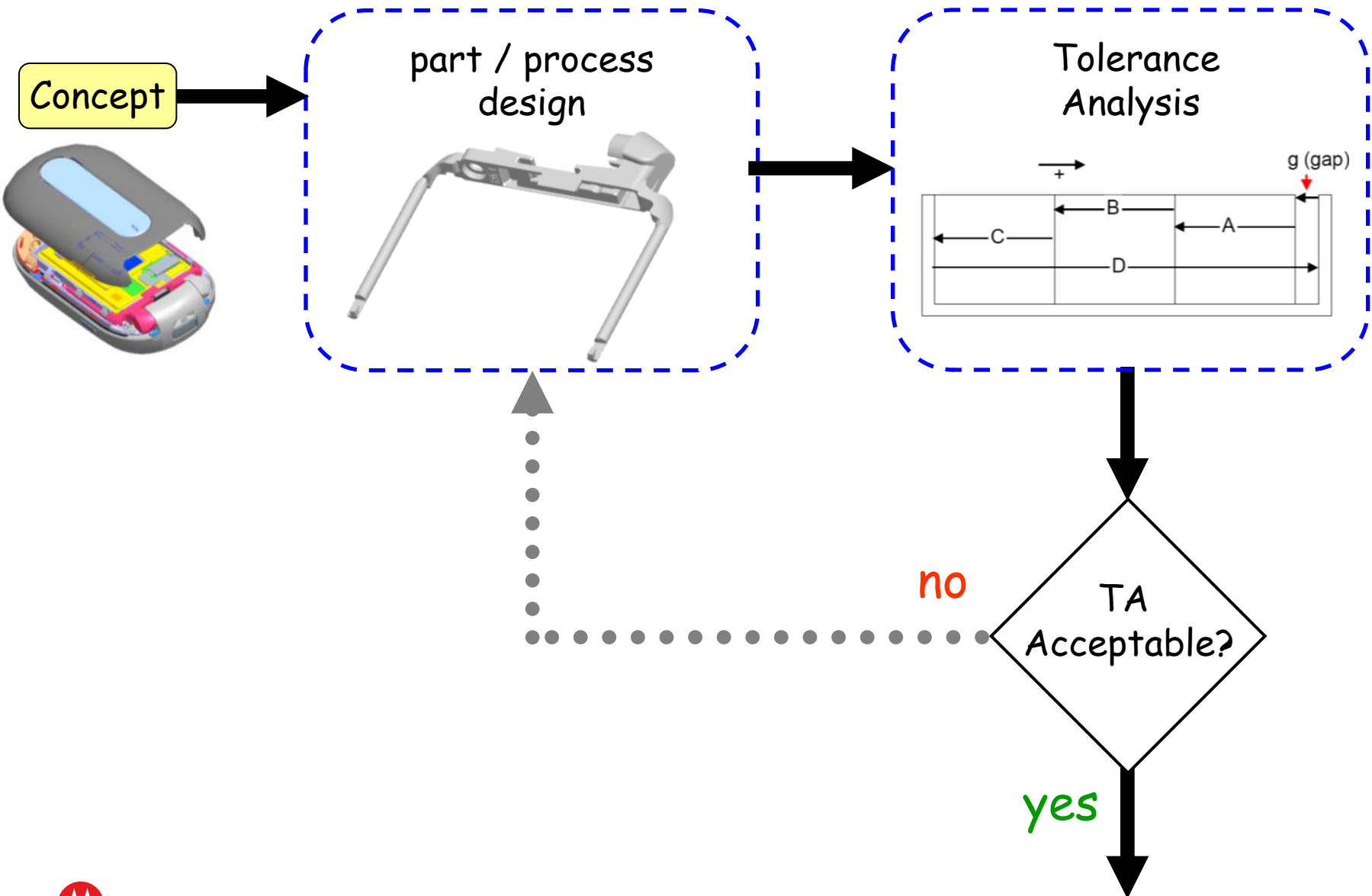
# **Mechanical Development Process**



# Tolerance Analysis

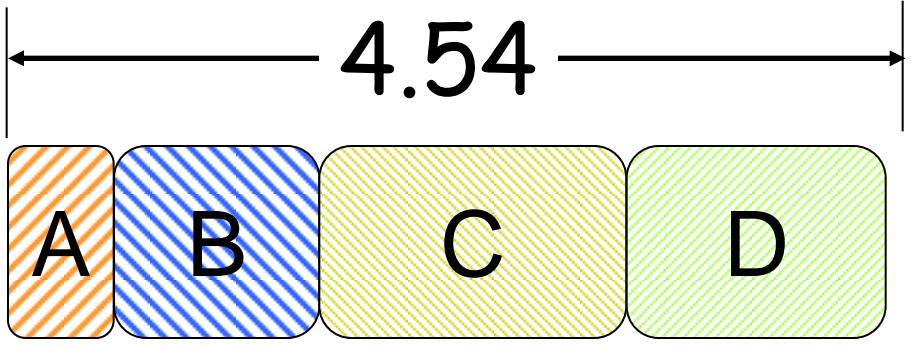
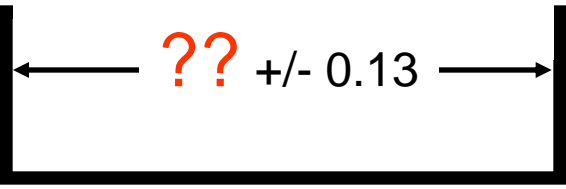
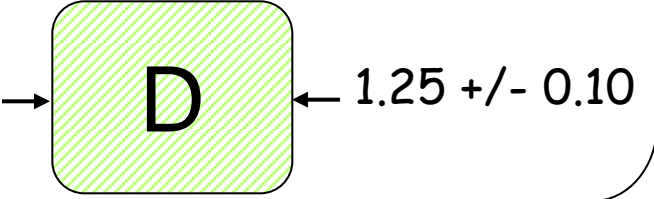
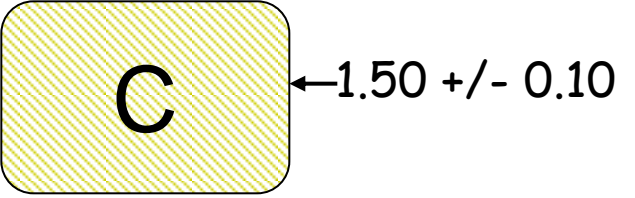
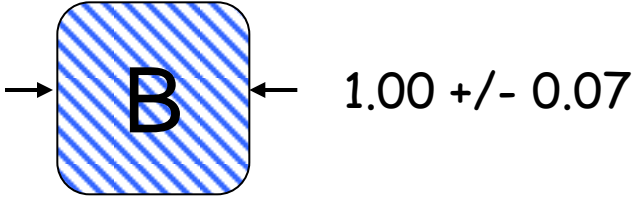
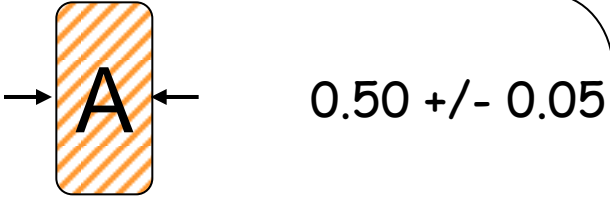


# Development Flow (simplified)



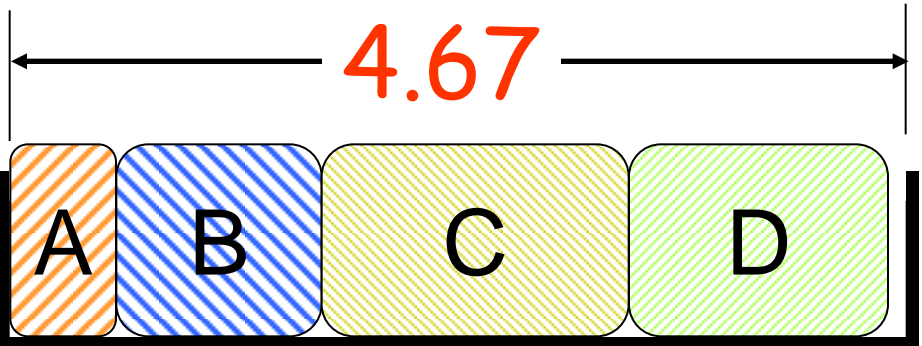
# Tolerance Analysis

## Components



0.55 + 1.07 + 1.60 + 1.35

## Envelope Size



## Root Sum Squared (RSS)

Variances can be added.....

$$\sigma^2 = \sigma_A^2 + \sigma_B^2 + \sigma_C^2 + \sigma_D^2 + \sigma_{\text{Envelope}}^2$$

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$$\sigma_{\text{gap}} = \sqrt{\left(\frac{T_e}{3C_p}\right)^2 + \sum_{i=1}^m \left(\frac{T_{pi}}{3C_{pi}}\right)^2}$$

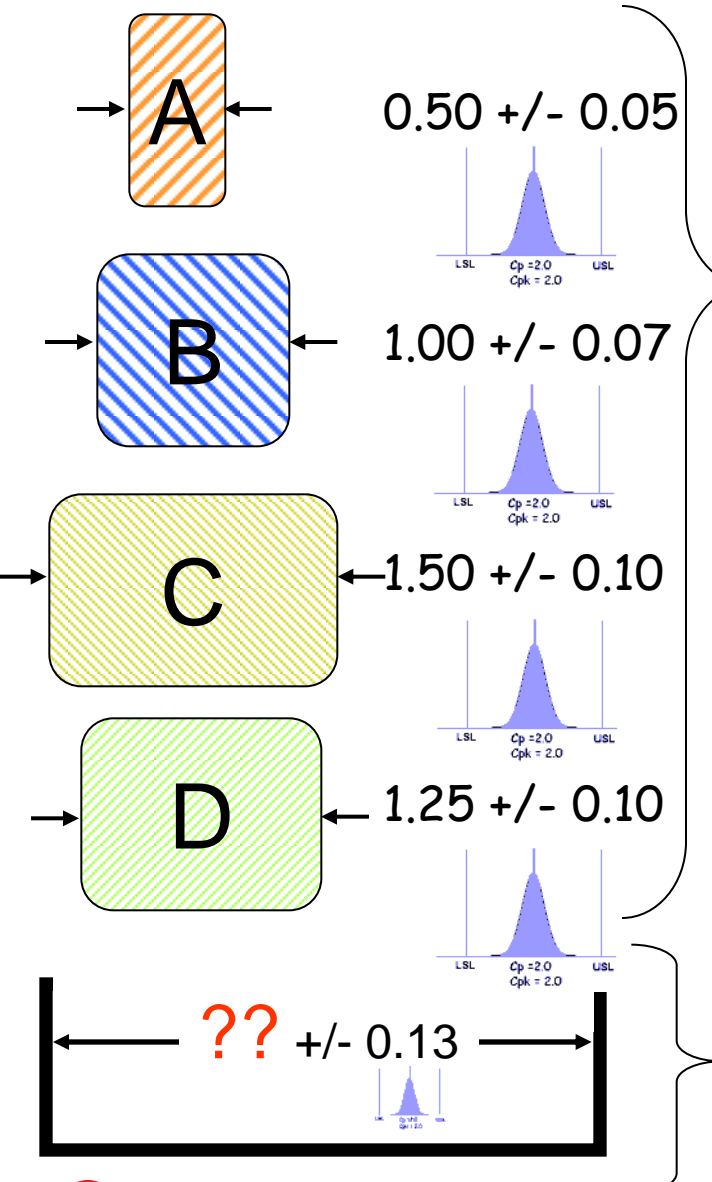
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$$\sigma_{\text{gap}} = 0.035$$



# Root Sum Squared (RSS)

## Components



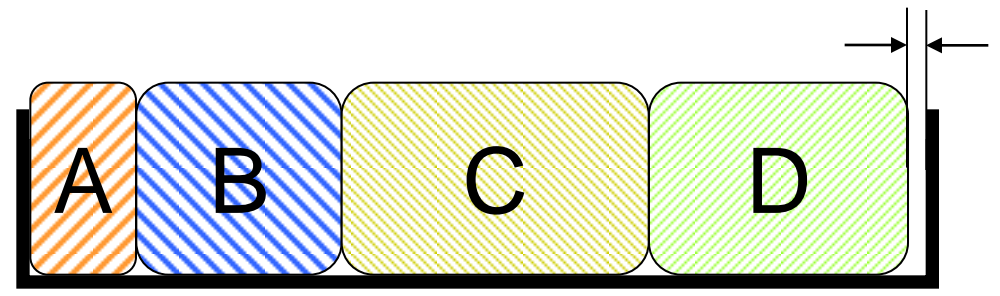
## Gap Size

$$\sigma_{\text{gap}} = 0.035$$

$$3\sigma_{\text{gap}} = 0.105$$

$$6\sigma_{\text{gap}} = 0.210$$

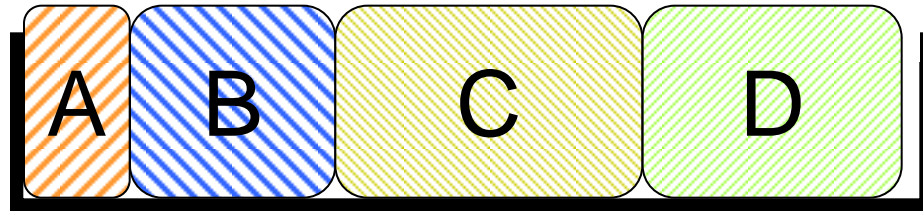
$$\text{Envelope} = A+B+C+D+6\sigma_{\text{gap}} = 4.46$$



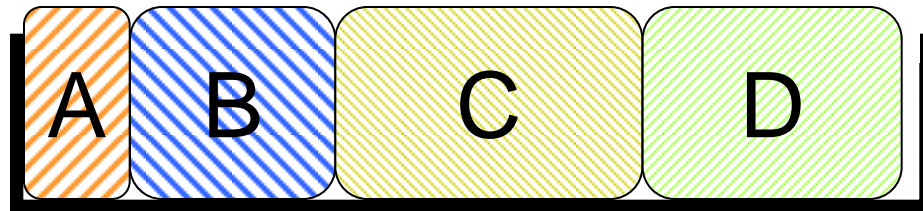


# RSS vs. Worst Case

Worst Case = 4.67



Statistical = 4.46



$\Delta = 4.5\%$

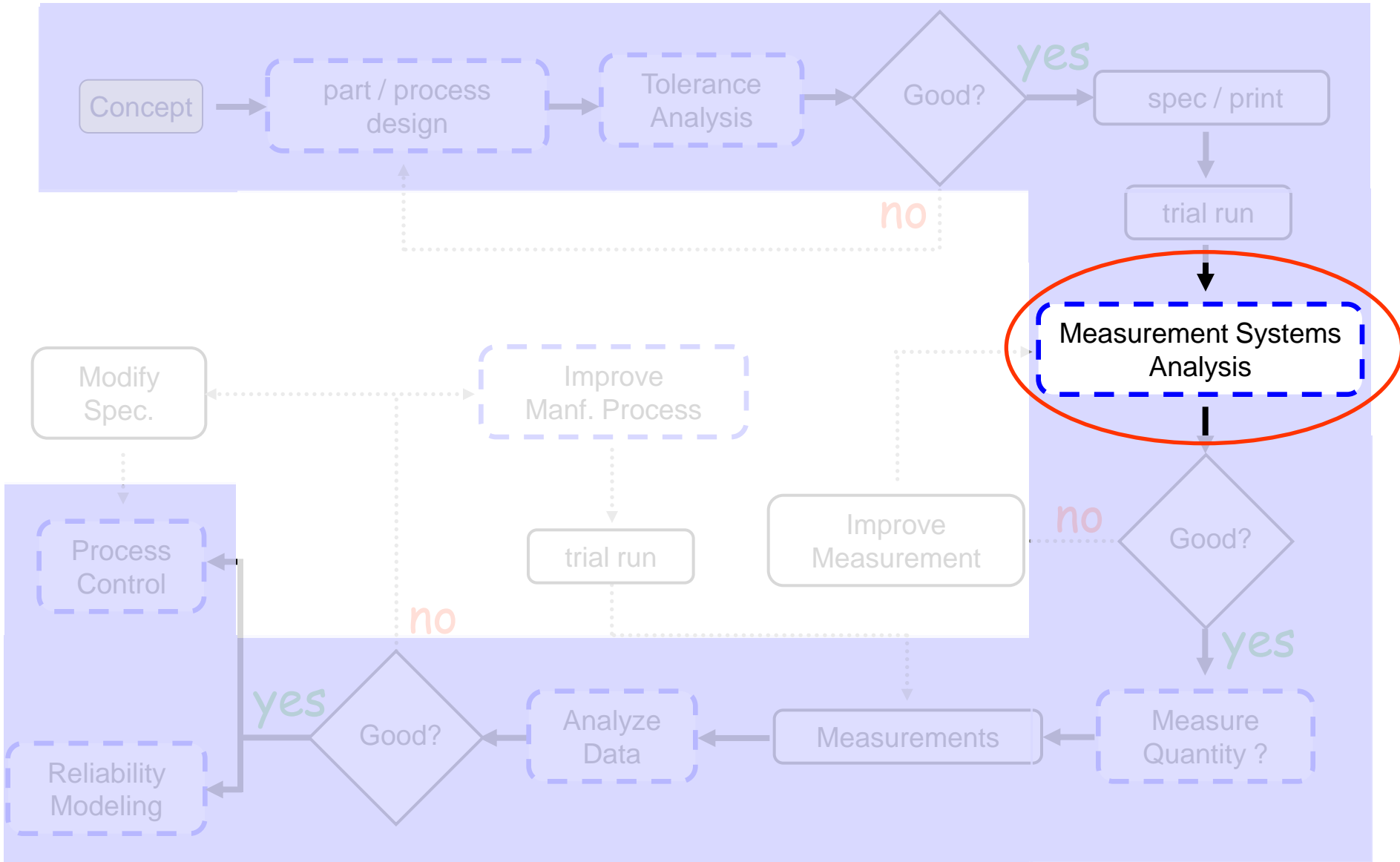


# TA Example:

## **uUSB and HDMI Connectors**

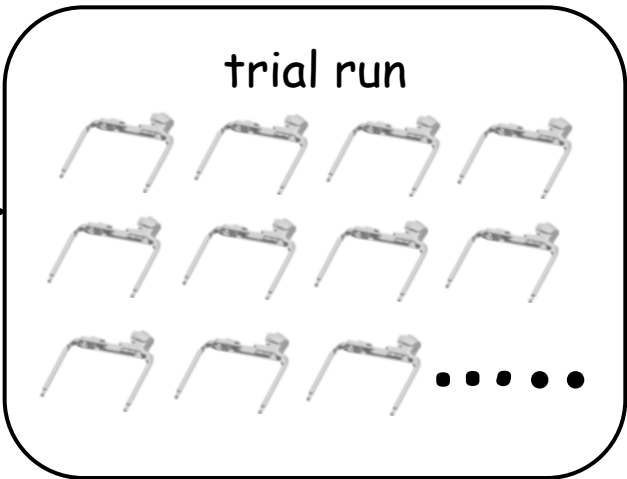
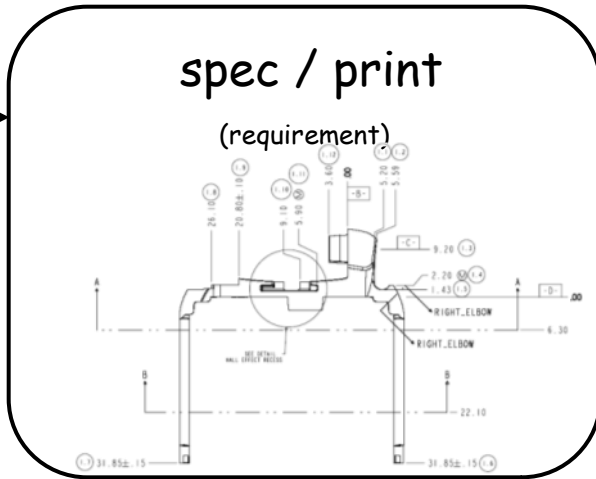
# **Measurement Systems Analysis (MSA)**

# Development Flow (simplified)



# Development Flow (simplified)

Good TA



# Measurement Systems Analysis

## WHY?

Measurement Error  $\longrightarrow$  Bad Decisions

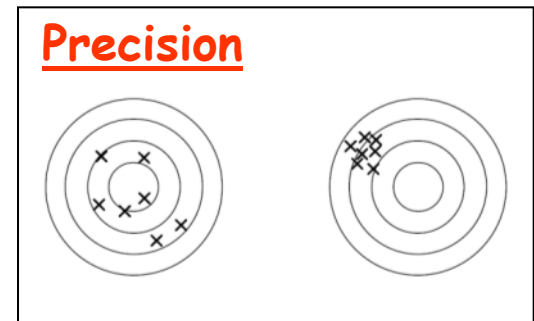
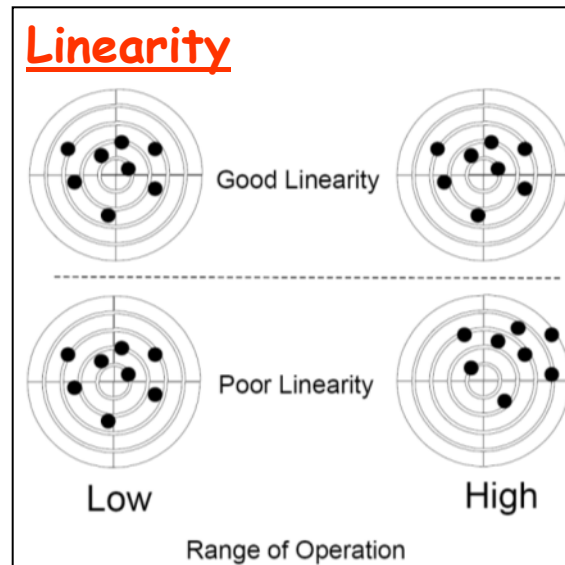
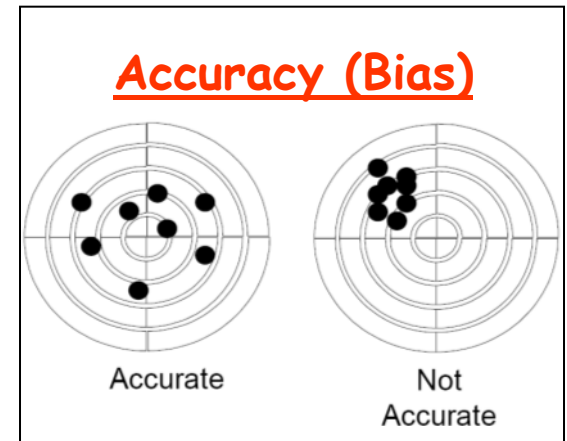
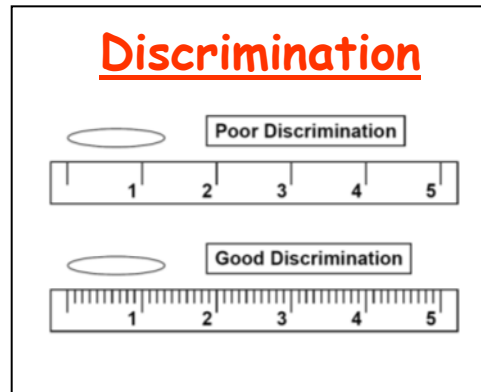
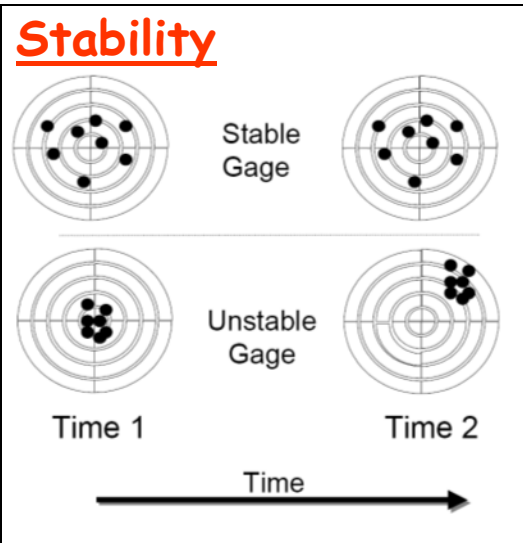
A **bad** unit  
might test “**good**”

A **good** unit  
might test “**bad**”



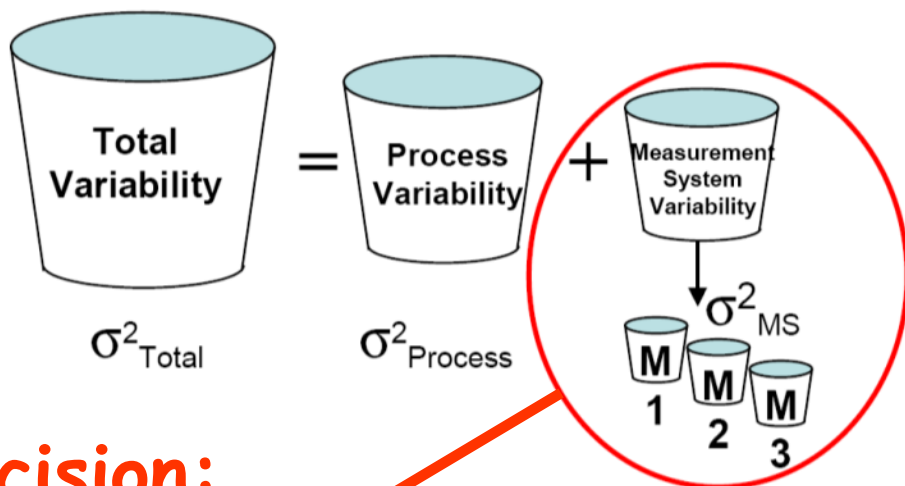
# Measurement Systems Analysis

## Characteristics:

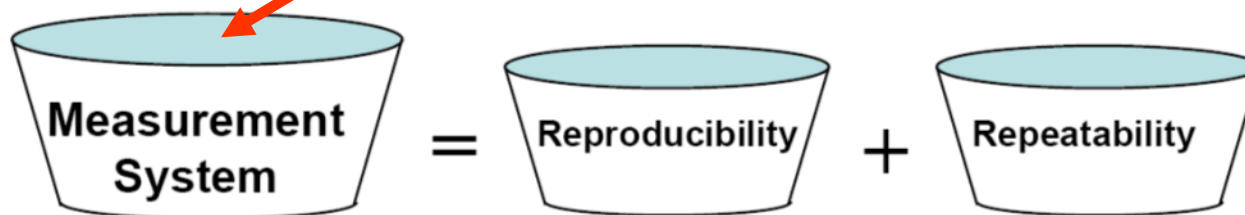


# Measurement Systems Analysis

## Total Variation:



## Precision:



$$\sigma^2_{\text{MS}} = \sigma^2_{\text{Reproducibility}} + \sigma^2_{\text{Repeatability}}$$

$$\sigma_{\text{MS}} = \sqrt{\sigma^2_{\text{Reproducibility}} + \sigma^2_{\text{Repeatability}}}$$





# MSA; %GR & R

% GR&R	
<10%	Acceptable
10% - 30%	Ok; non-critical measurements
>30%	Unacceptable



**Measurement Systems  
Analysis  
Example:**

**Glue Weight**

# Measurement Size



# Sample Size

- Dependent on the type of analysis to be performed
- Apply applicable formula
- Example: Sample Mean to a known population

$$n = \frac{(Z_{\alpha} + Z_{\beta}) \cdot \sigma^2}{\delta^2}$$

$\alpha$  = level of acceptability of a false positive (0.05 is typical)

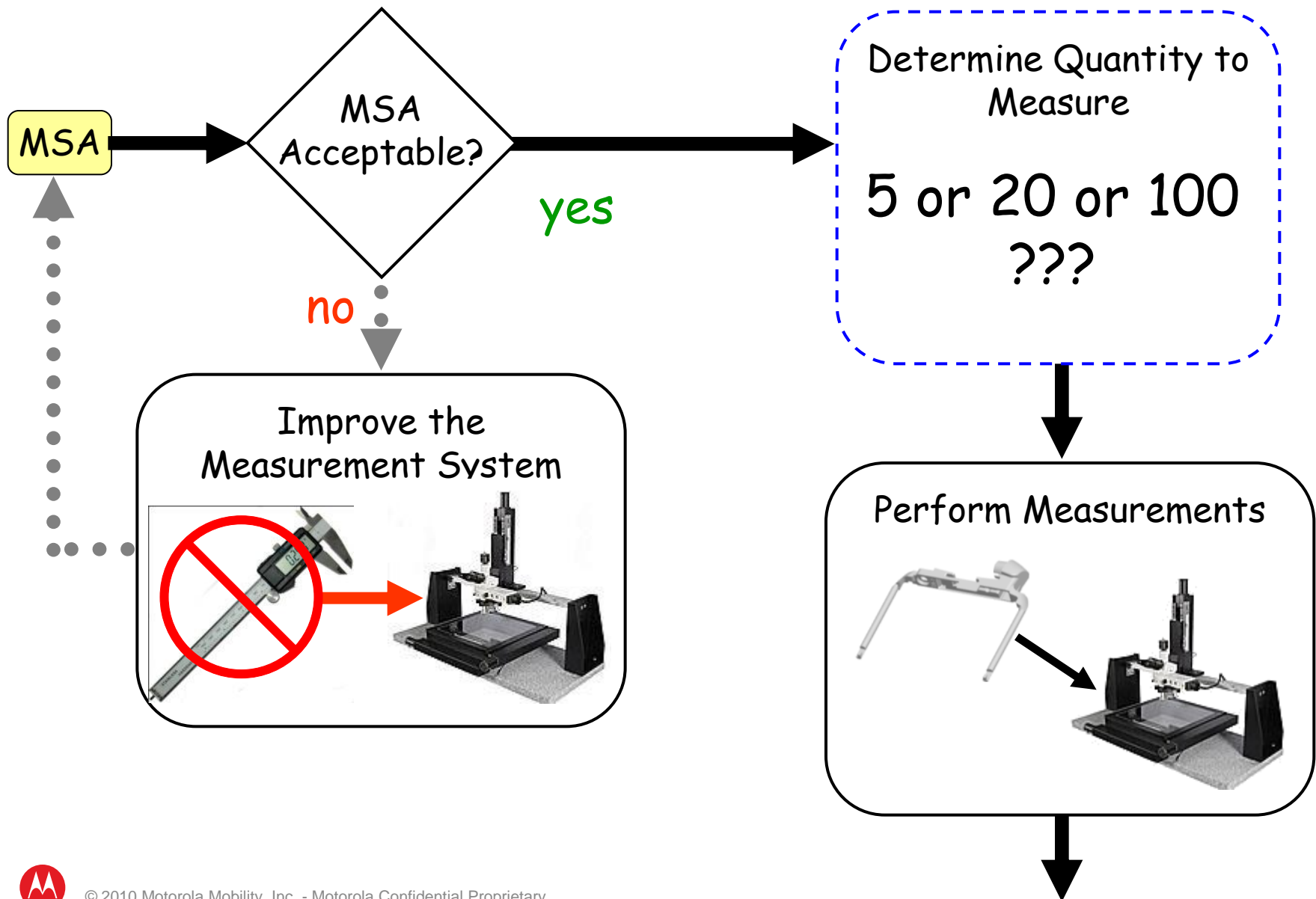
$\beta$  = level of acceptability of a false negative (0.10 is typical)

$\sigma$  = known standard deviation

$m$  = amount of difference that matters (practical difference)

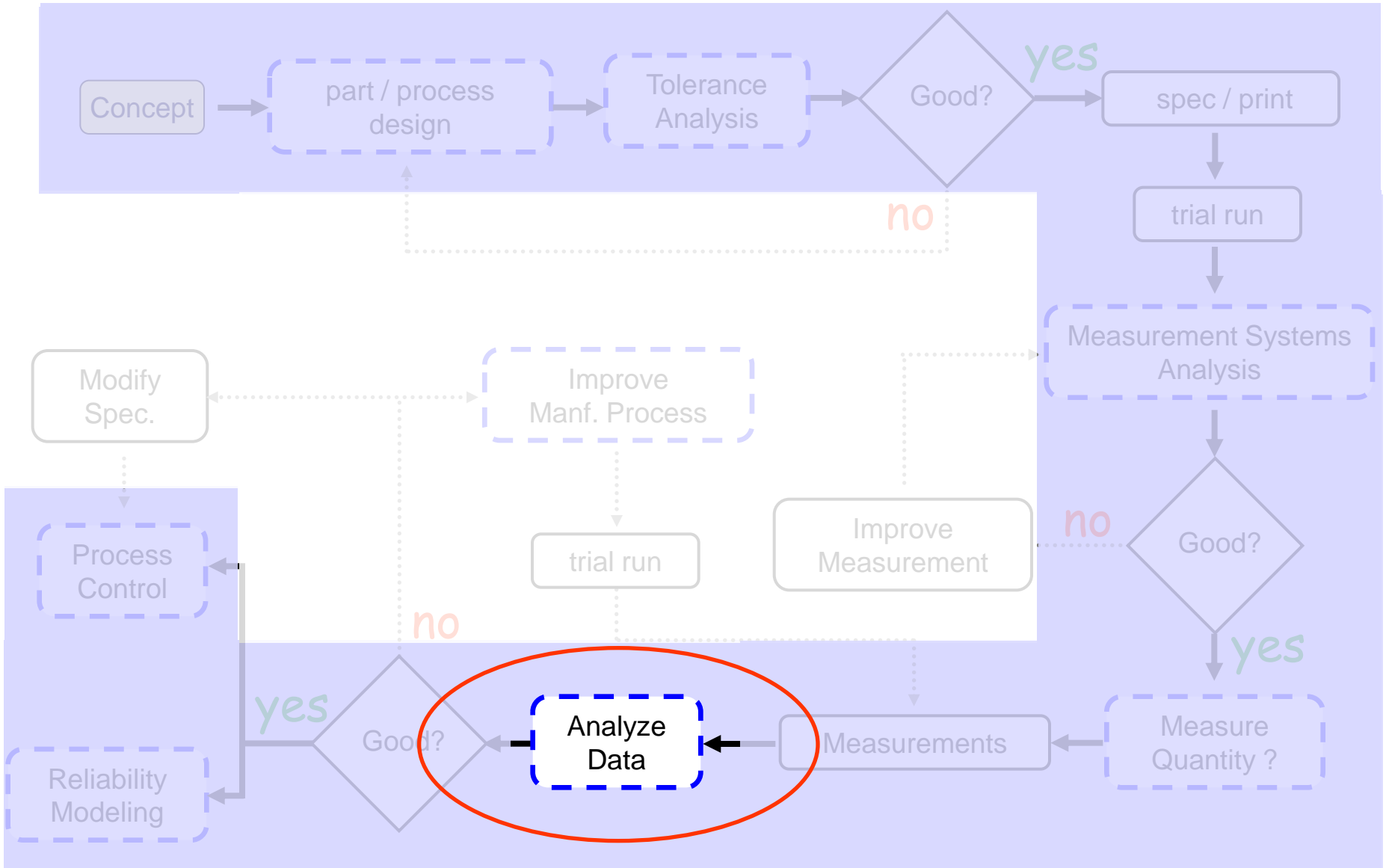


# Development Flow (simplified)



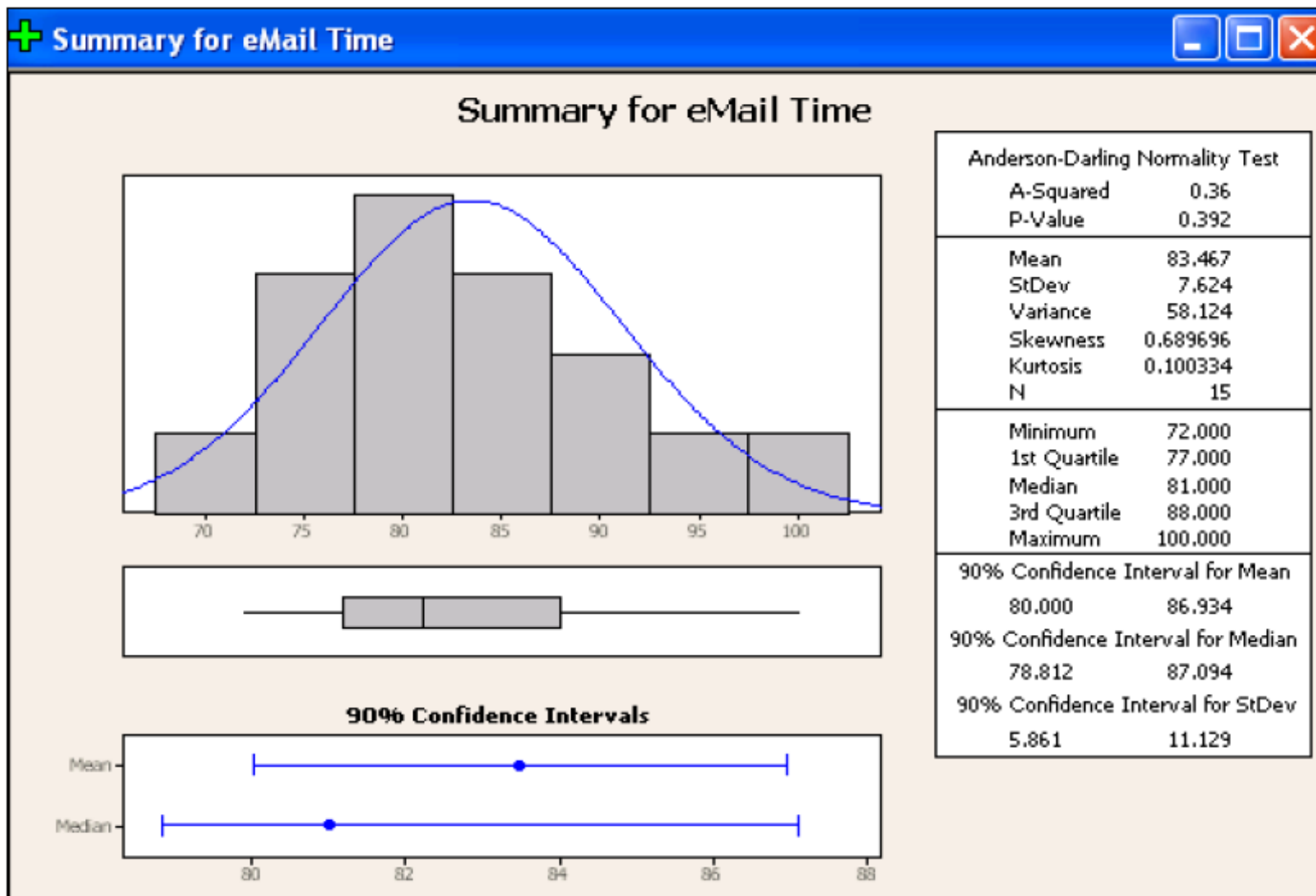
# Data Analysis

# Development Flow (simplified)

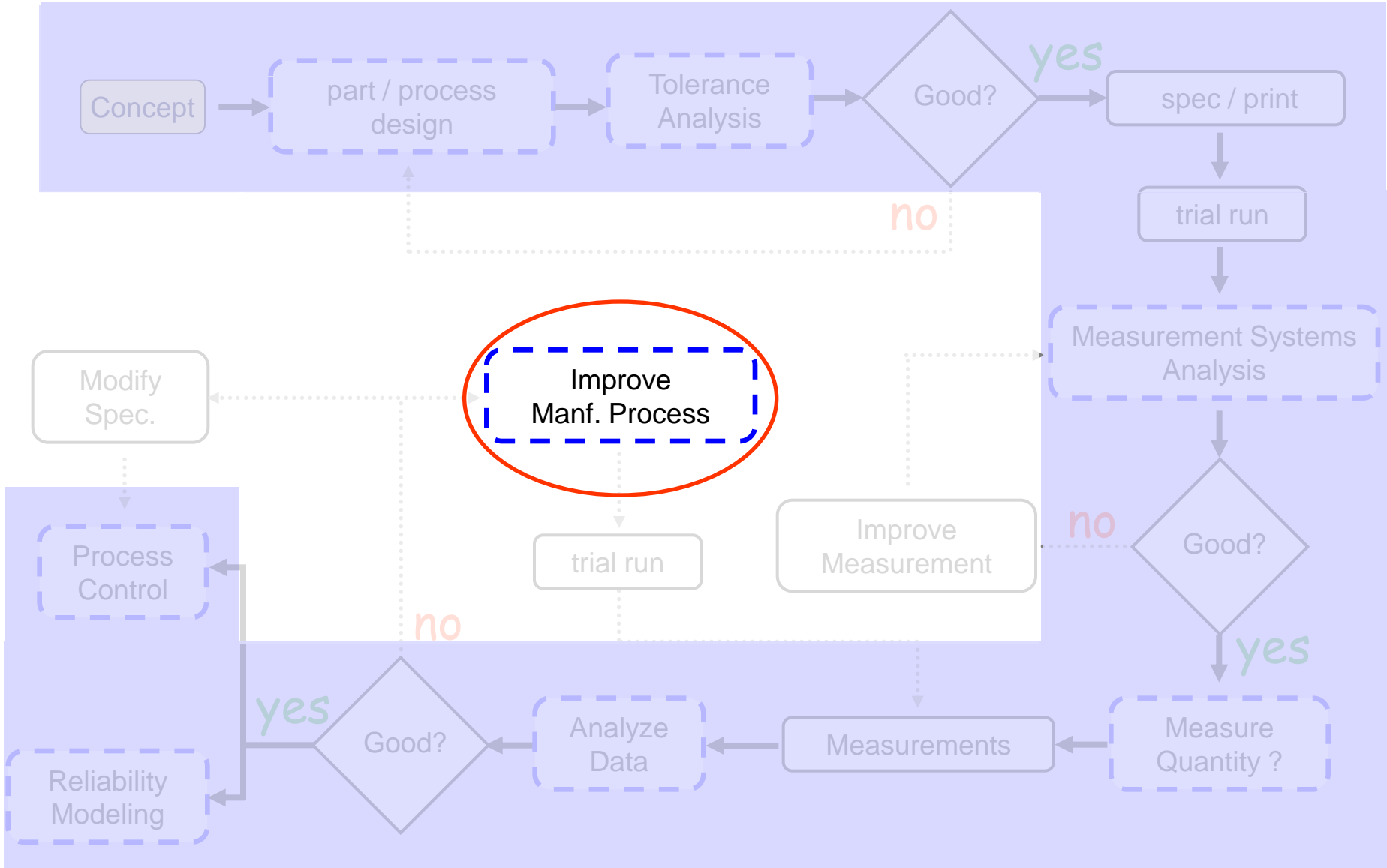




# Data Analysis



# Development Flow (simplified)



**Comparative Analysis  
&  
Design of Experiments  
(DOE)**

# Comparative Methods

- Analytical method to evaluate changes & differences.
- Examples:
  - Different vendors
  - Change to a process

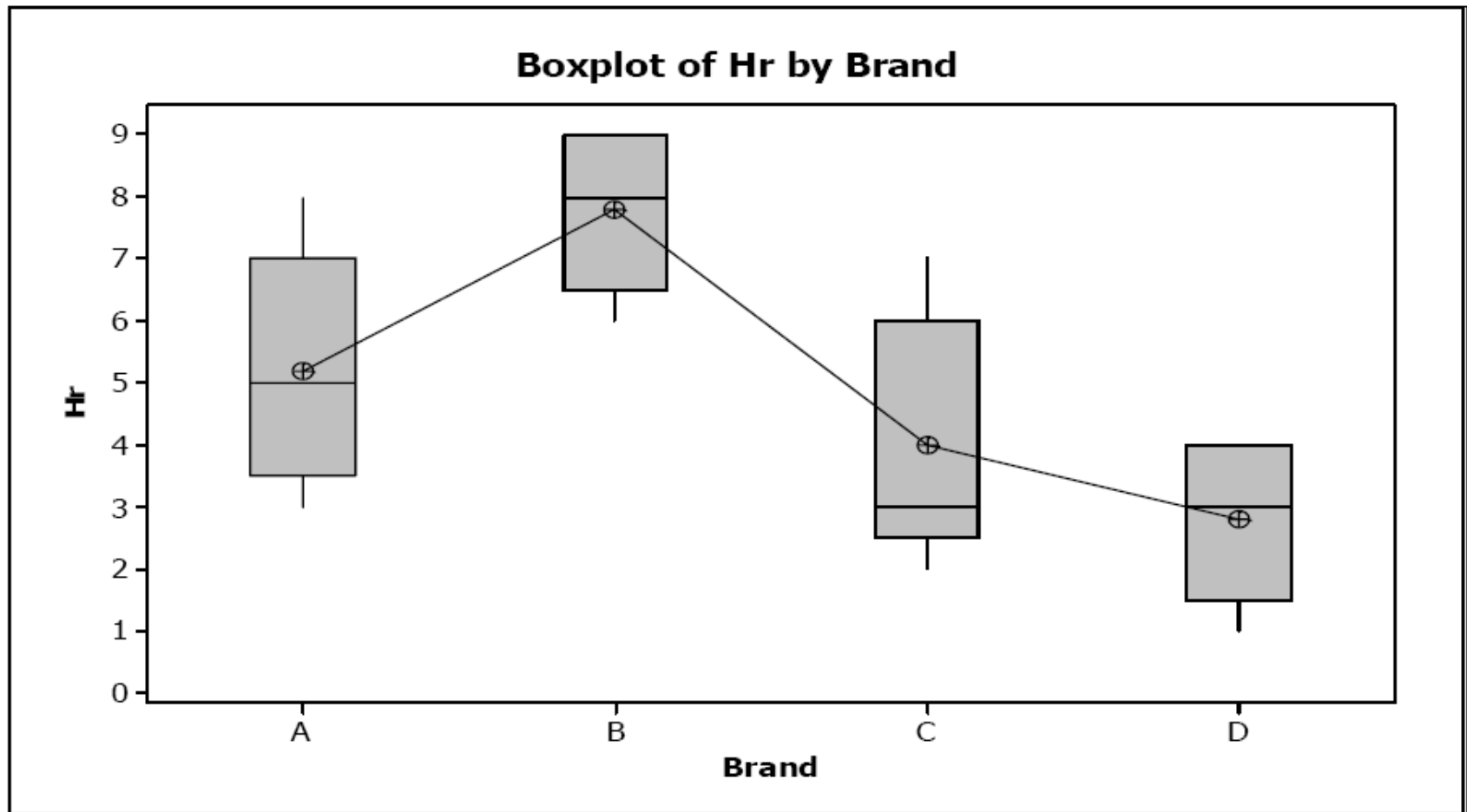
Types of Comparisons

	Y continuous	
X discrete	Mean	Standard Dev.
1-STD	1 sample t-test	$\sigma$ Confidence interval
1-1	2 sample t-test	F test
Multiple	One-way ANOVA	Graphical Bartlett Levene



# Comparative Methods

## Multiple Comparisons - Averages



# Comparative Analysis

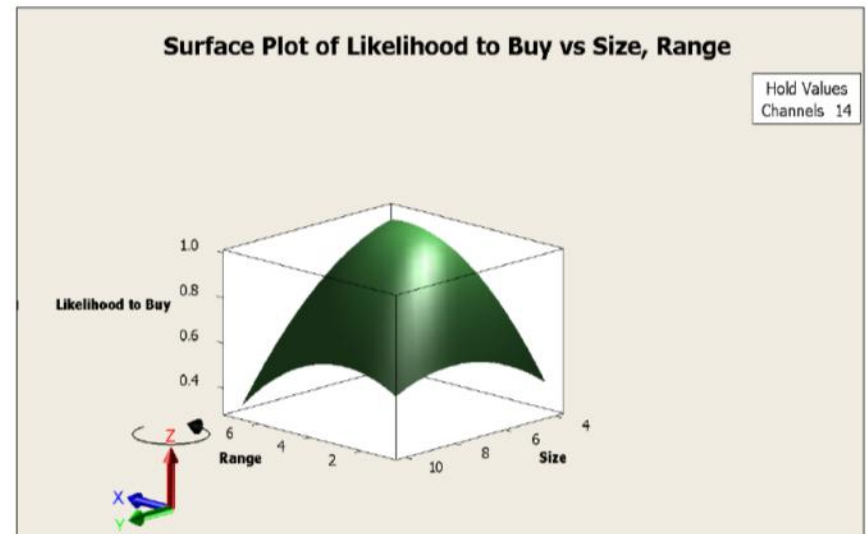
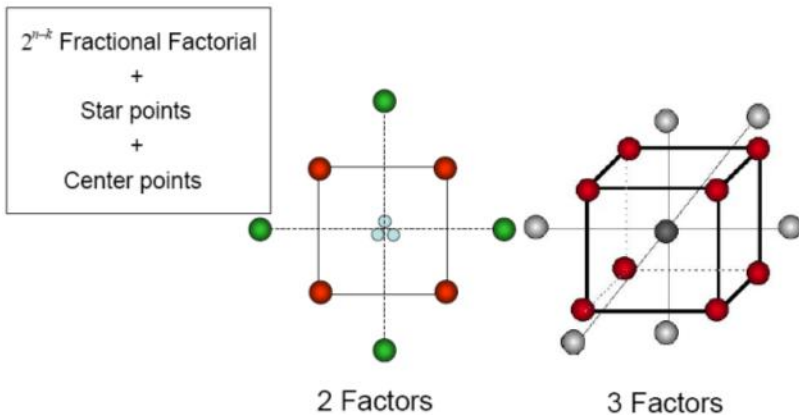
## Example:

**PCB Bow**

# Design of Experiments

- Efficient Experimental Method
- Optimizes Processes and Designs
- Allows for the Analysis of Interactions

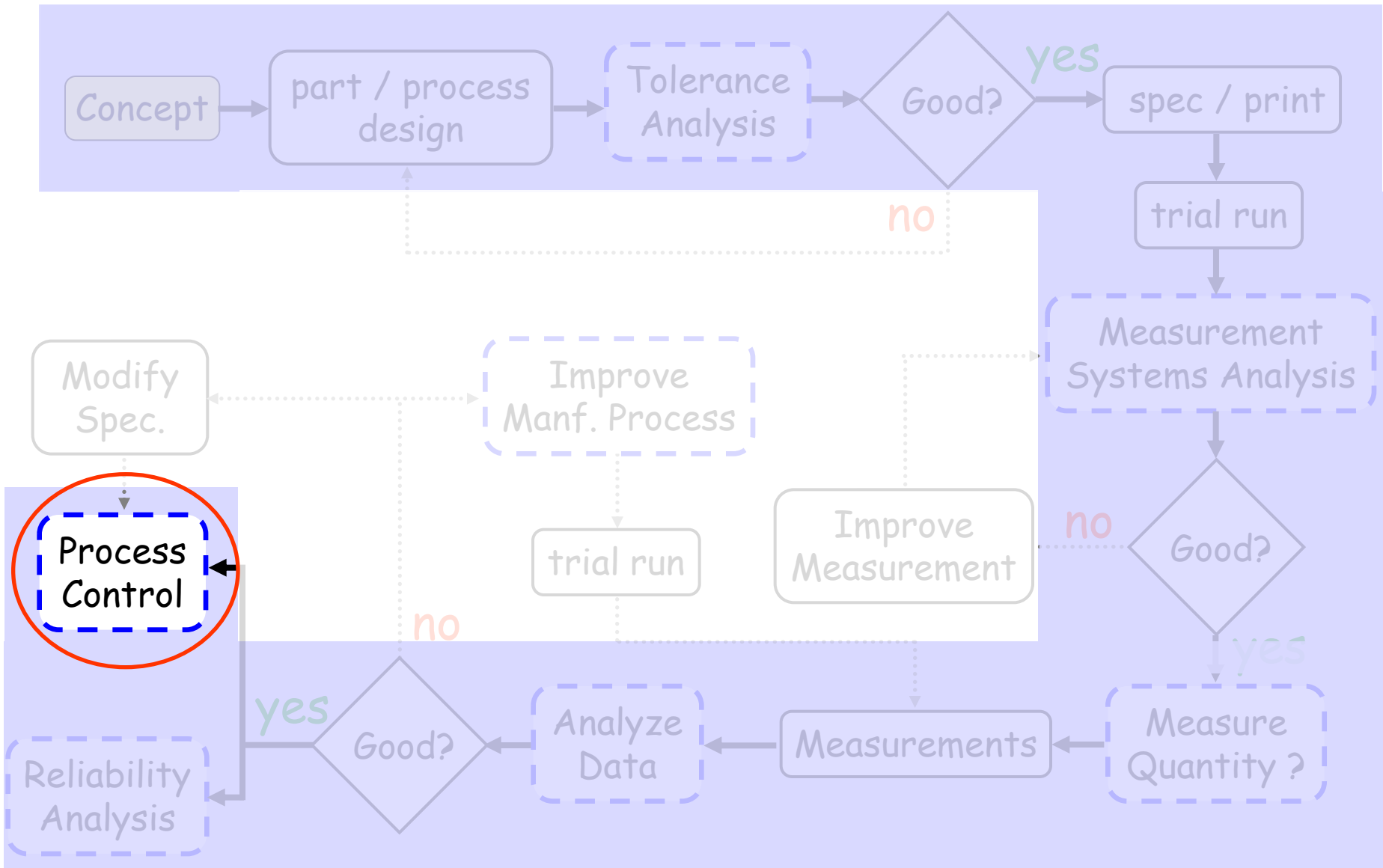
General Structure for a Central Composite Design



# Process Control

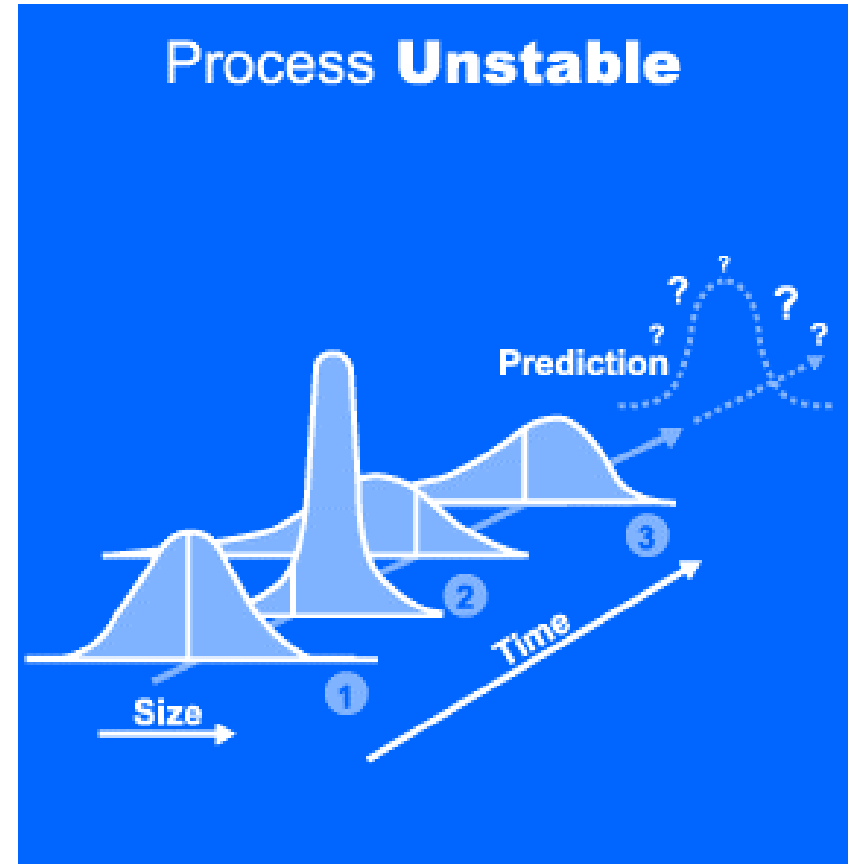
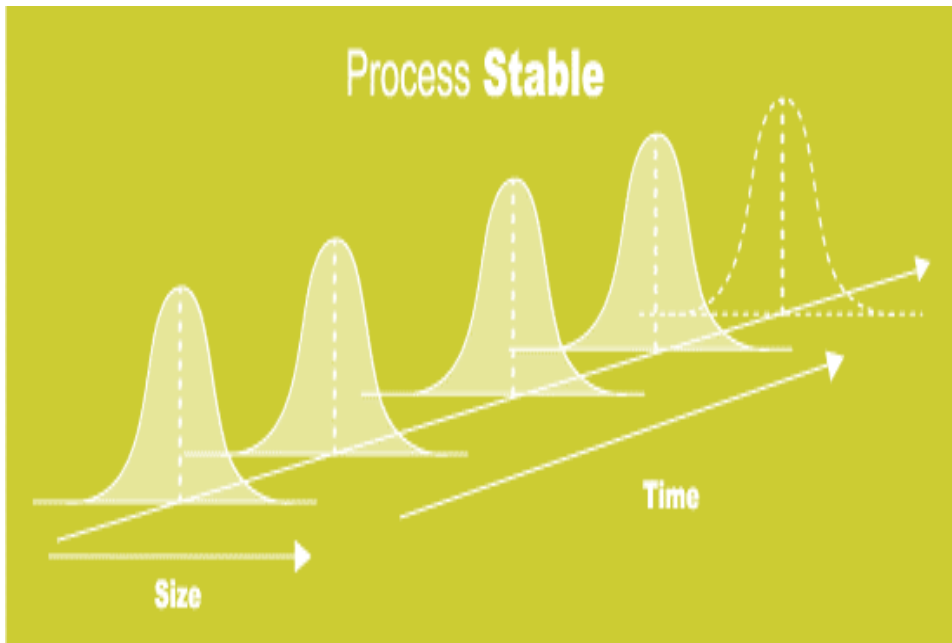


# Development Flow (simplified)



# Process Control

# Statistical Process Control

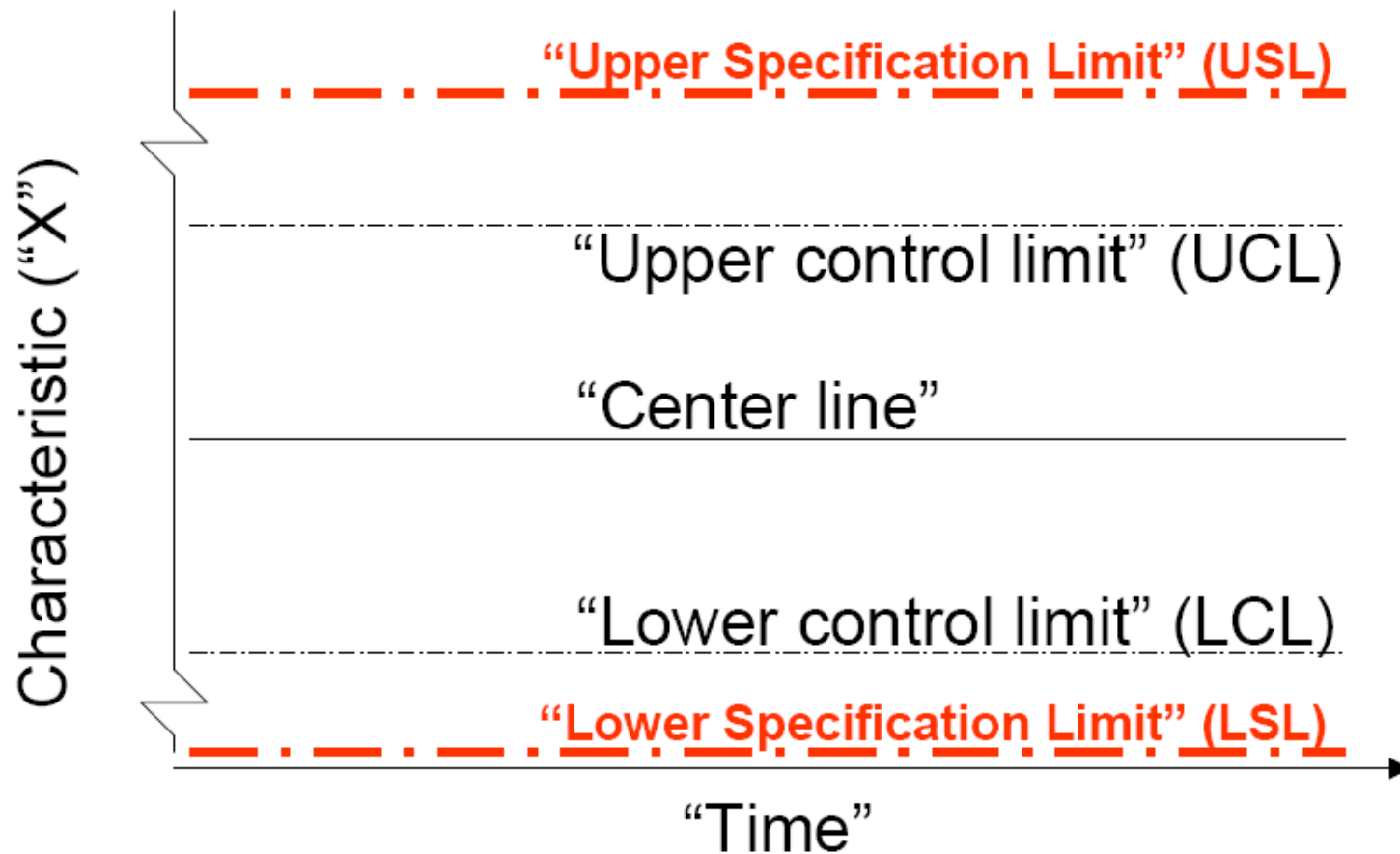


## SPC Goals:

- Predicable process
  - Consistent  $\sigma$  ( $C_p$ )
  - Centered distribution ( $C_{pk}$ )



## Control Limits vs. Specification Limits



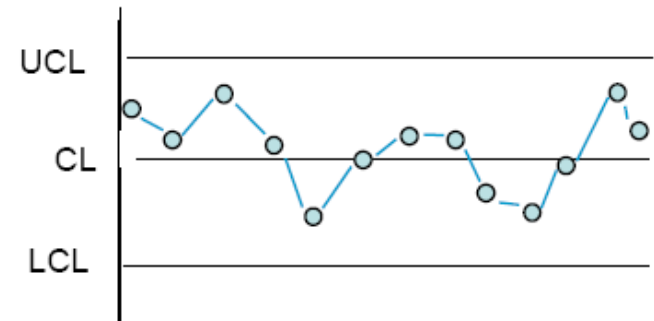
# Control Charts

## Decision Rules for Process Control

Process  
In  
Control



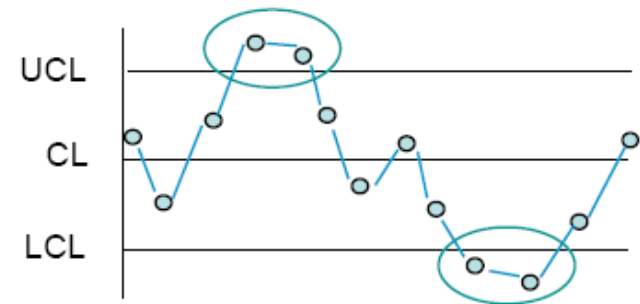
Chart points do not  
form a particular  
**pattern** AND lie within  
the upper and lower  
chart limits



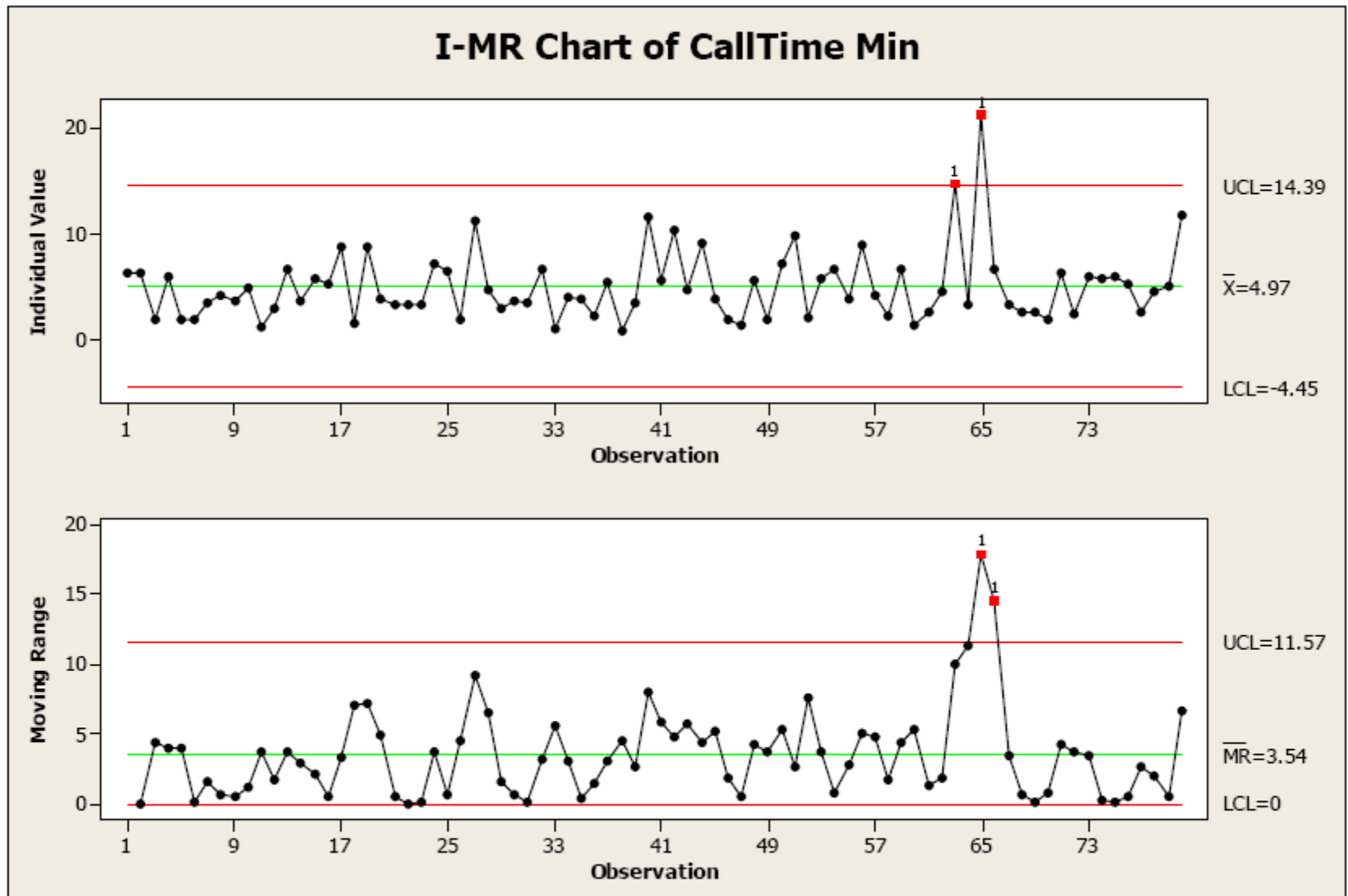
Process  
Out of  
Control



Chart points form a  
particular pattern OR  
one or more points lie  
**beyond** the upper or  
lower chart limits

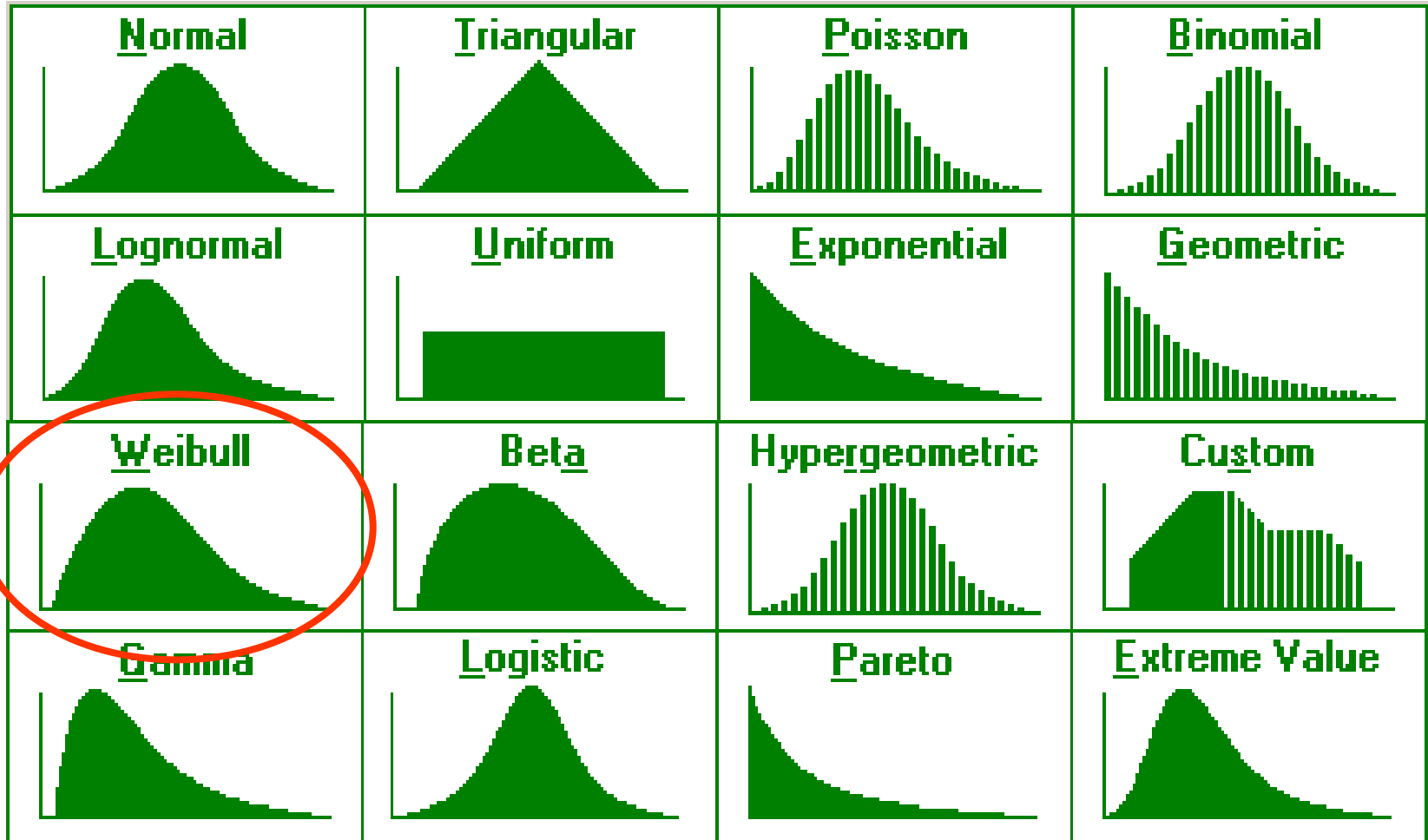


# Control Charts (X-bar / R)



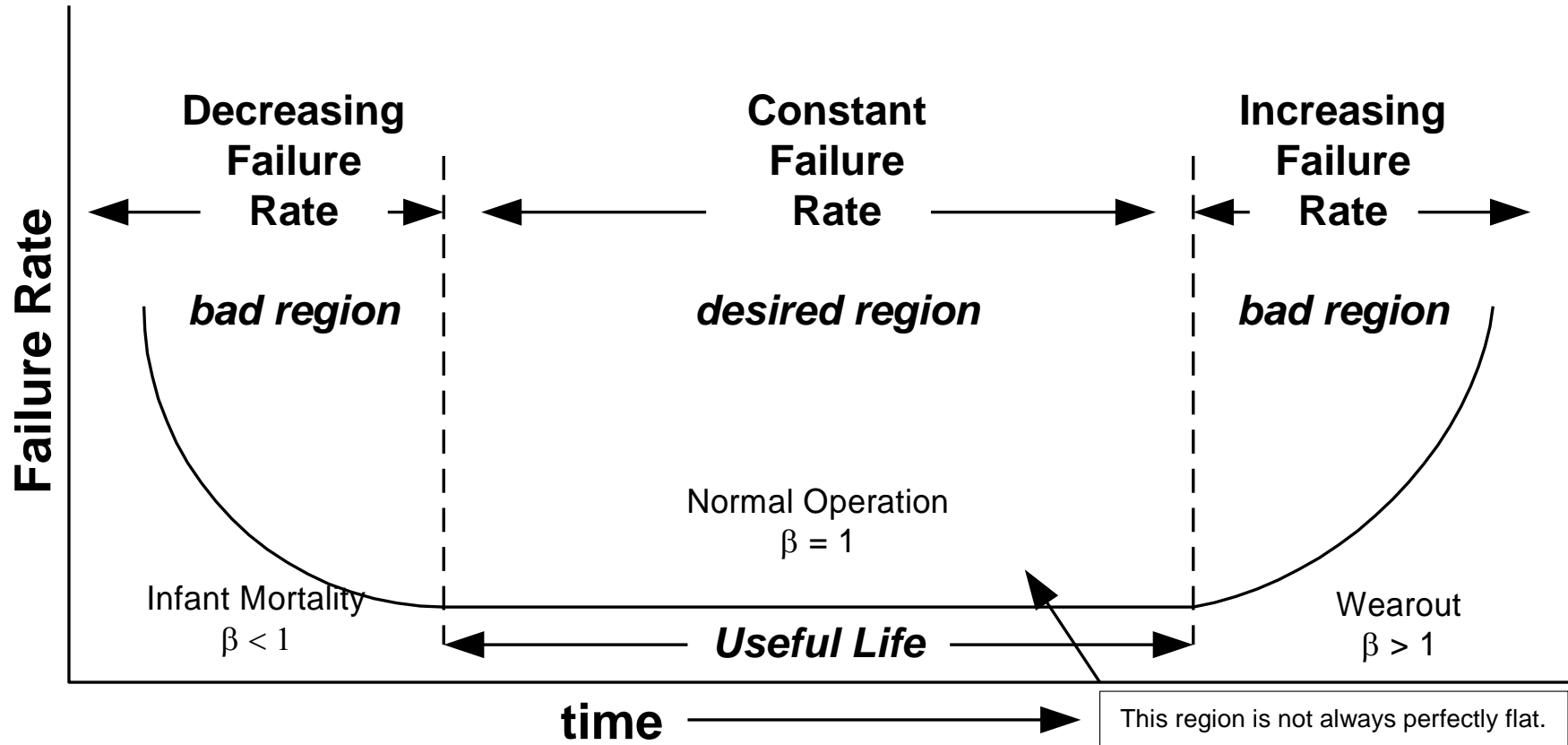


# Reliability Analysis





# Reliability Analysis



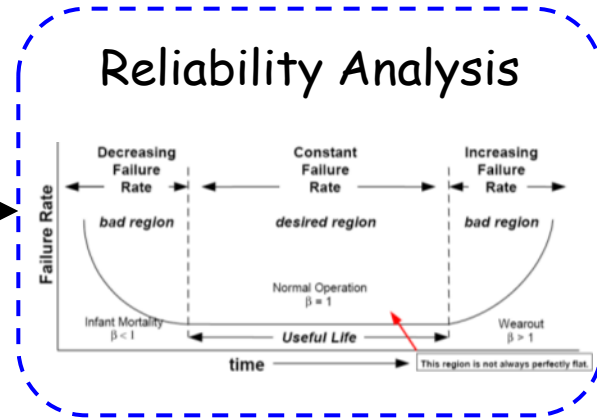
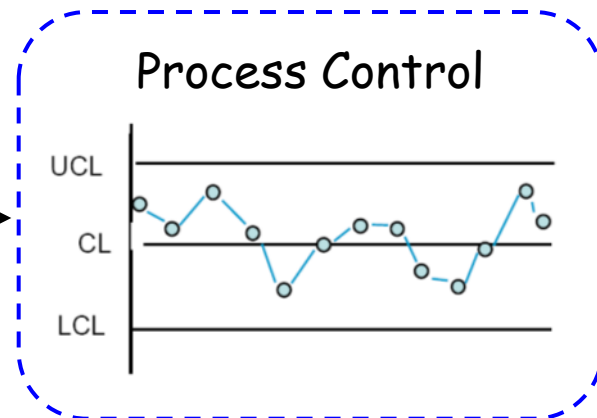
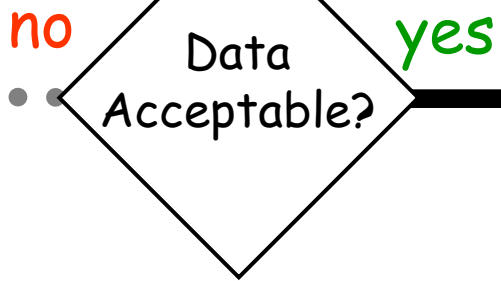
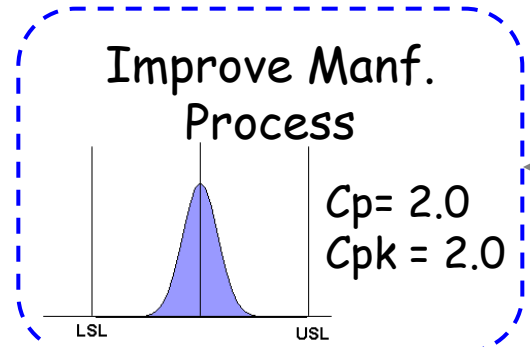
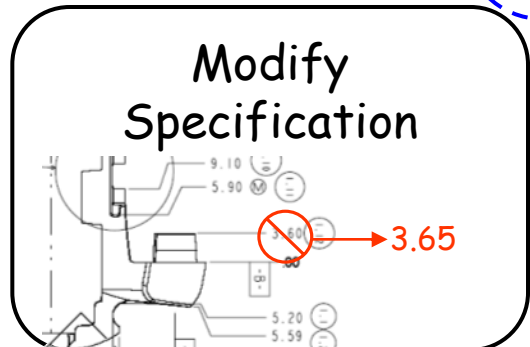
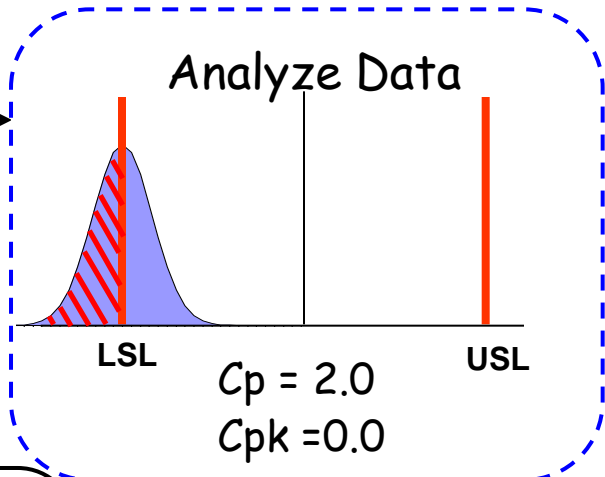
# **Failure Analysis**

## **Example:**

# **Display Breakage**

# Development Flow (simplified)

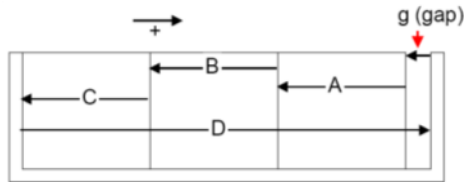
Measurement Data



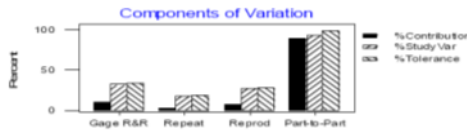
# Tools Used

# DFSS Tools

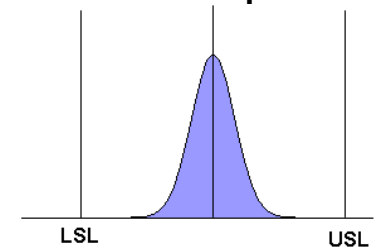
## Tolerance Analysis



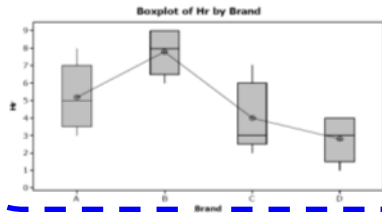
## Measurement System Analysis



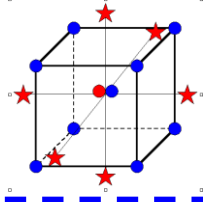
## Process Capability



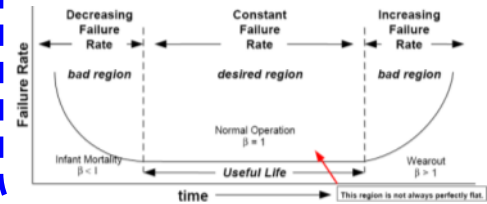
## Comparative Methods



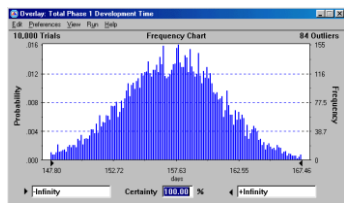
## Design of Experiments



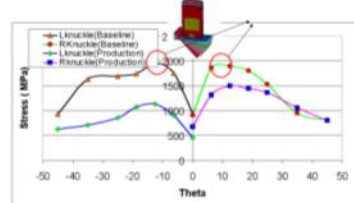
## Reliability Modeling



## Monte Carlo Simulation



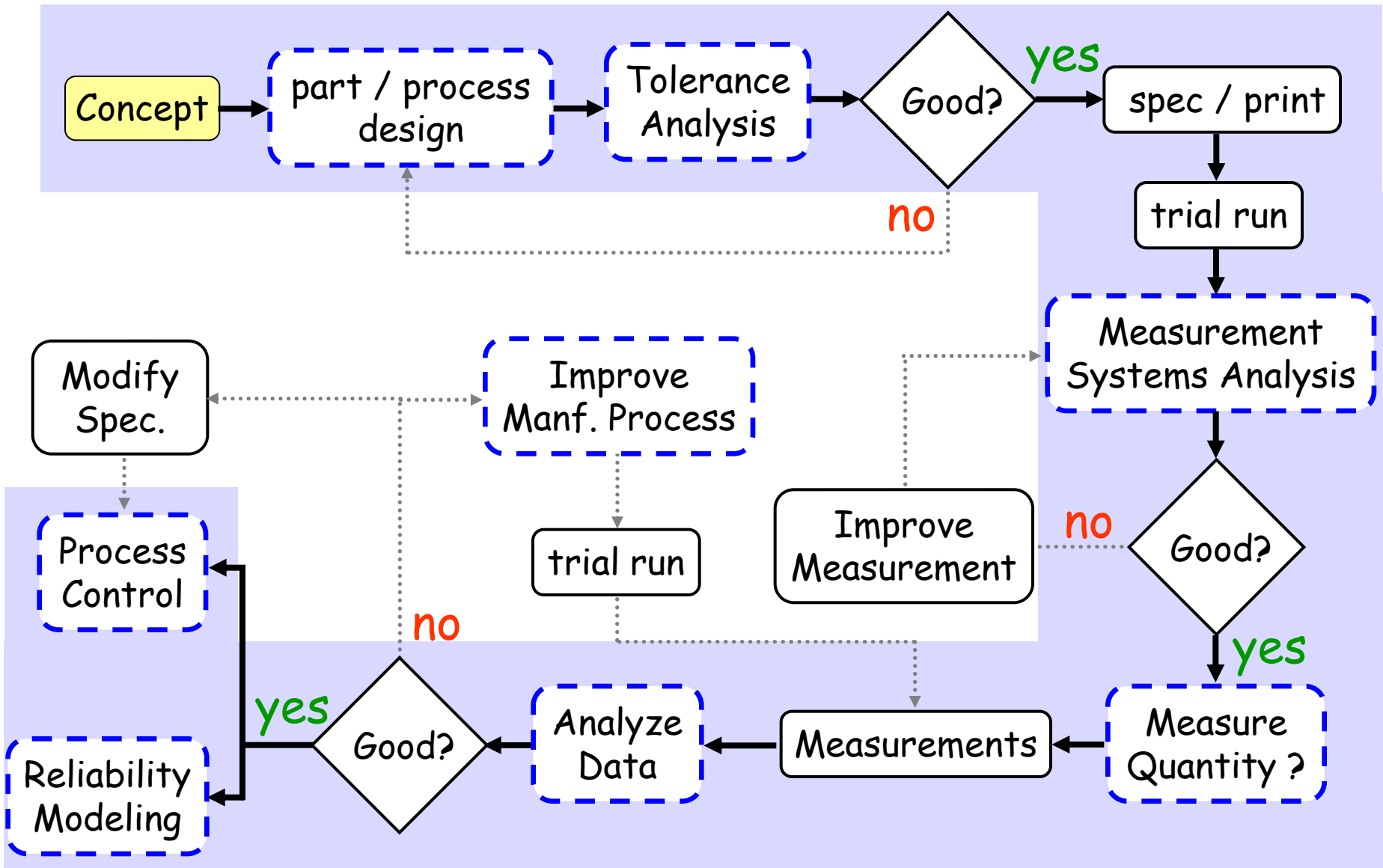
## DACE



Etc....



# Development Flow (simplified)



# Why Statistical Methods

- Disciplined Approach
- Repeatable Results
- Quantifiable Decision Criteria
- Optimization

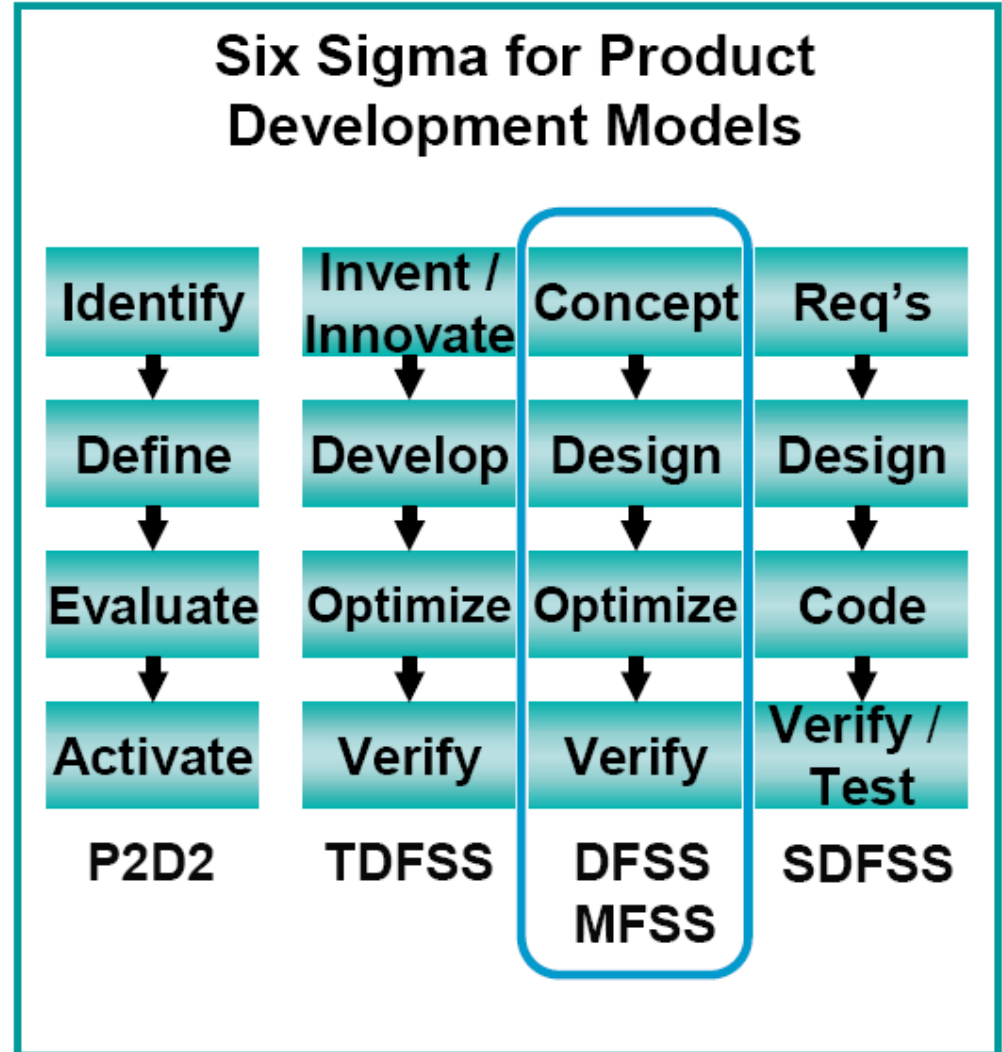
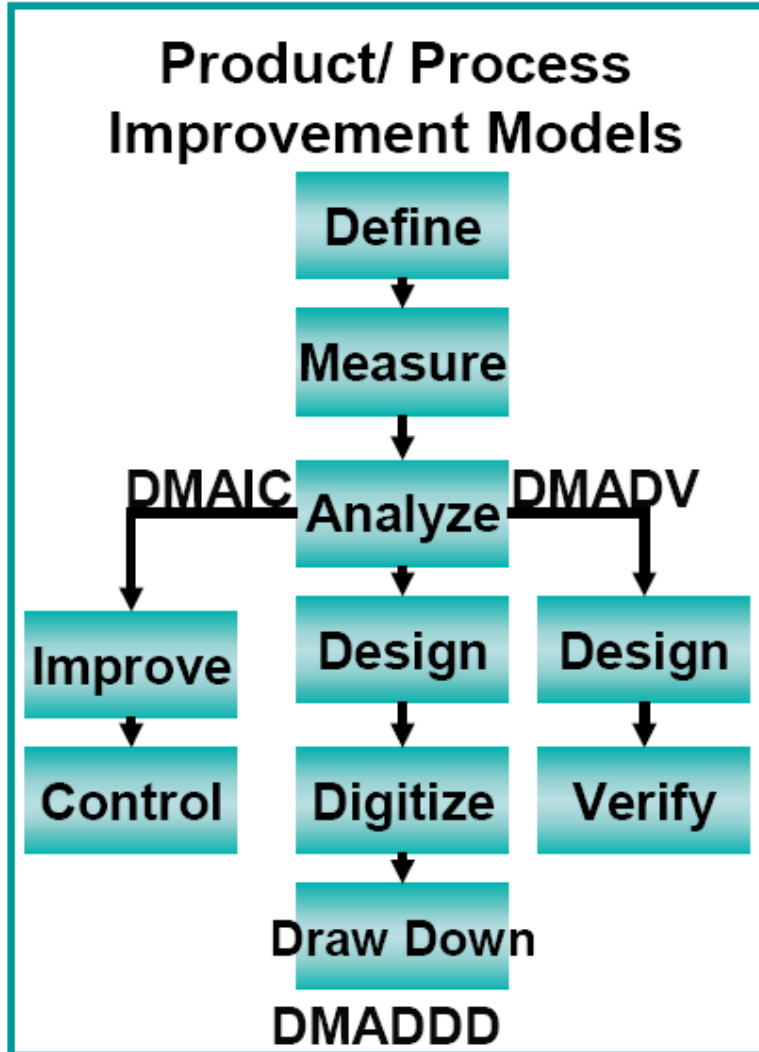


**Q & A**



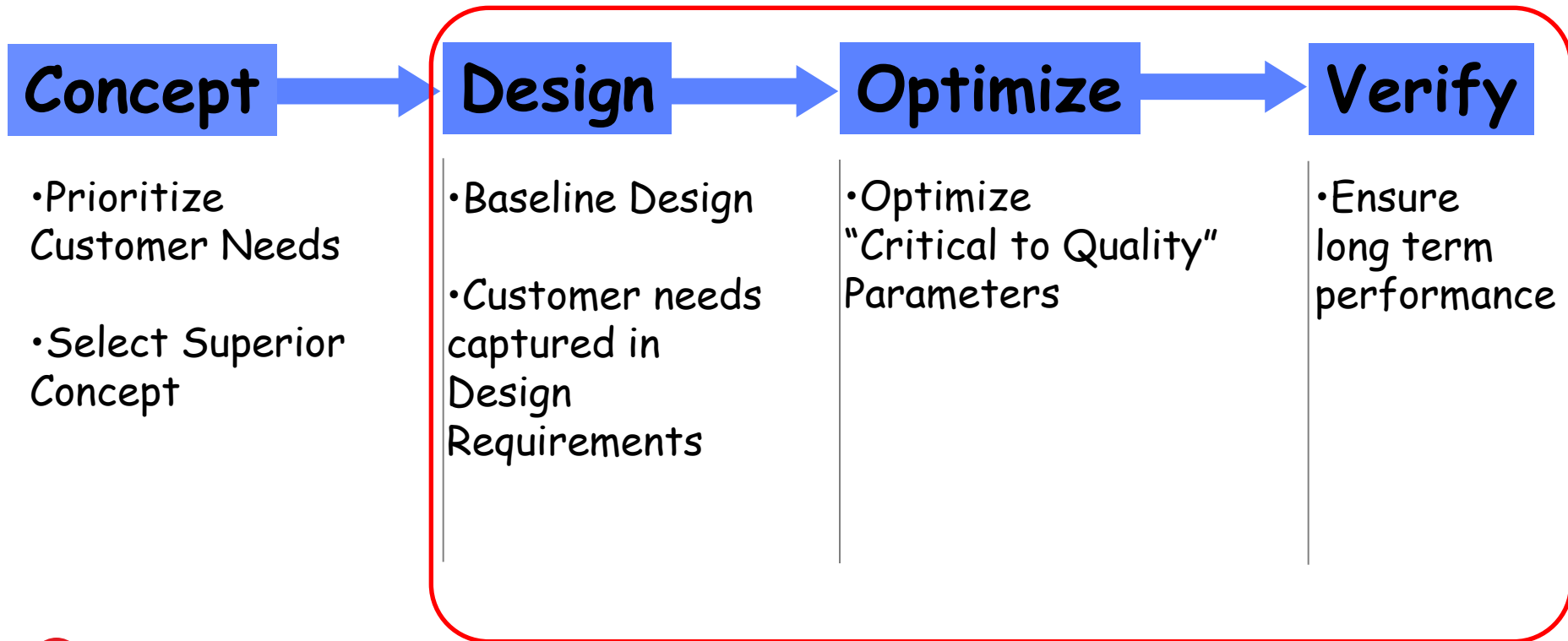
**Back Up Slides**

# 6 Sigma Methodology



## DFSS - Design for Six Sigma

# CDOV



# CDOV Process

## Concept

Major Steps	VOC	KJ Analysis	Initiate CPM	Pugh Analysis
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## Design

MSA	Process Capability	Confidence Intervals	Comparative Methods	Monte Carlo	CPM	FMEA	Control Charts
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## Optimize

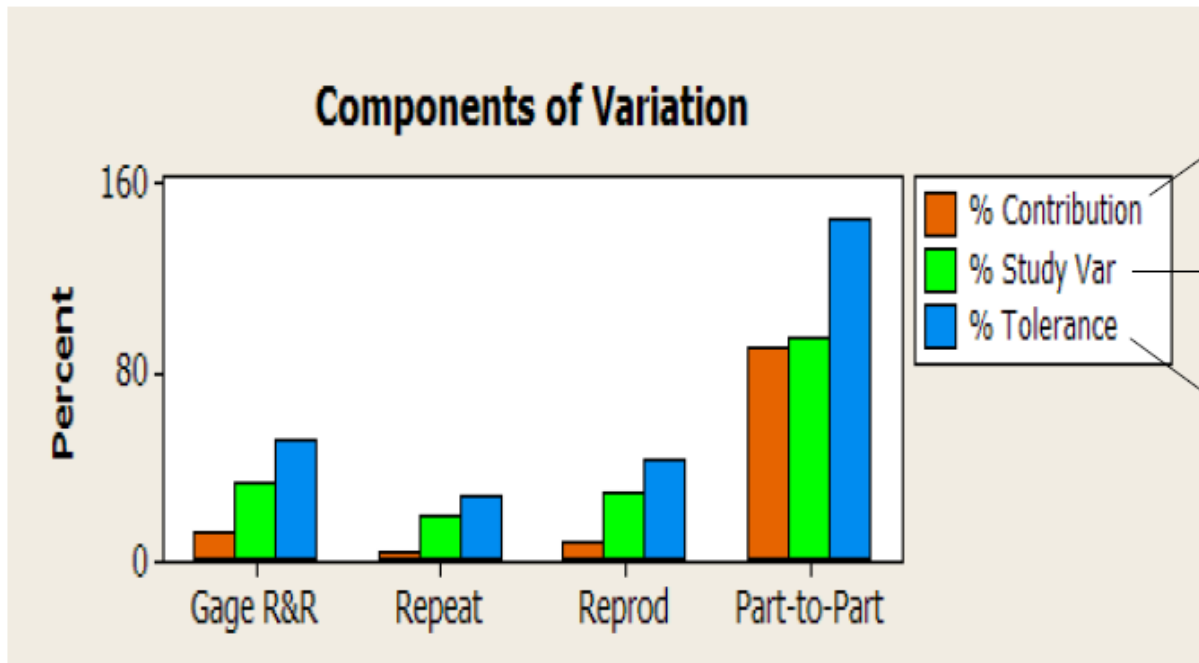
Regression	DOE	RSM	Robust Design	Tolerance Analysis	DACE
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## Verify

Reliability Modeling	System Reliability	System Availability
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# Measurement Systems Analysis



$$\frac{\sigma_{MS}^2}{\sigma_{Total}^2} \times 100$$

$$\frac{6 \times \sigma_{MS}}{6 \times \sigma_{Total}} \times 100$$

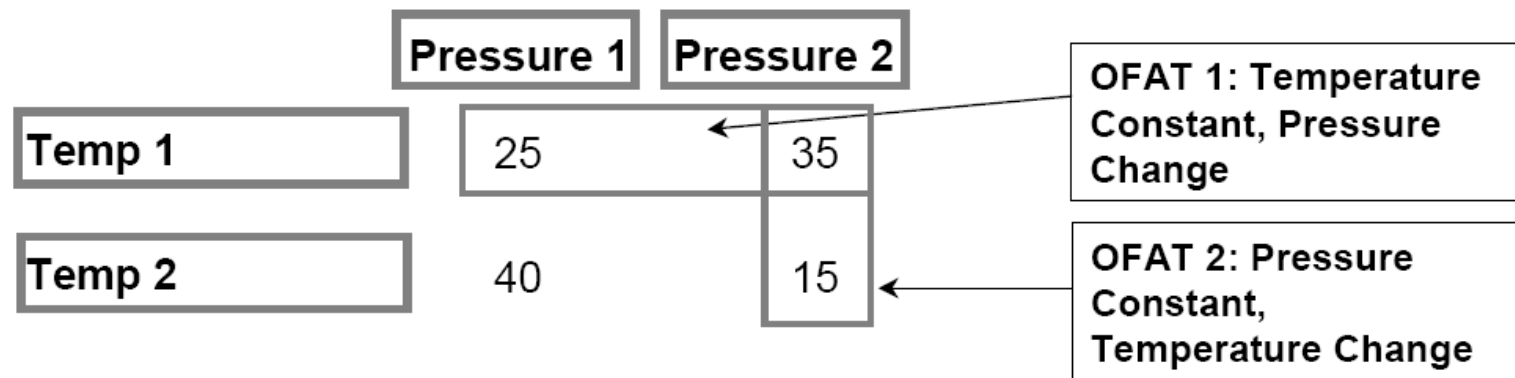
$$\frac{6 \times \sigma_{MS}}{USL - LSL} \times 100$$

- Shows %R&R, its components and part to part variation
- We want the Gage R&R bars to be as small as possible



# Design of Experiments

## One Factor At a Time (OFAT) Example



- If we held Temp constant at level 1 and varied Pressure, we would conclude that Pressure at level 2 is best.

## OFAT – Disadvantages

- Easy but not efficient
- Does not allow the investigation of the combined effects of factors (Interactions)
- Does not cover a wide experimental region



# Design of Experiments

Factors		Response
Speed (Mph or Kph)	Brake Force (pounds or Newtons)	Stopping Distance (yards or meters)
-1	-1	50
-1	+1	30
+1	-1	250
+1	+1	150

Level<sup>Factors</sup>  $\rightarrow 2^2 = 4$  Runs



# Design of Experiments

## Analysis - Main Effects – Factor B (Brake Force)

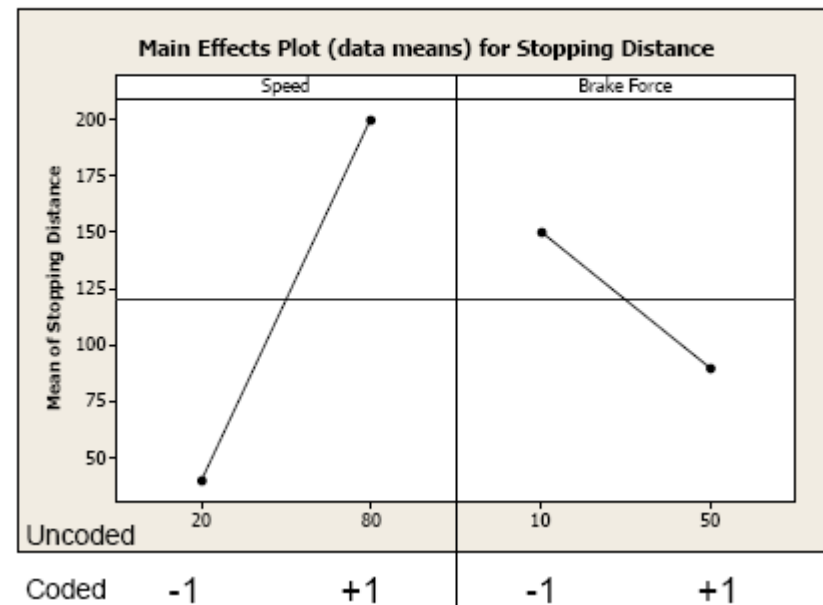
	Speed	Brake Force	Response
	-1	-1	50
	-1	+1	30
	+1	-1	250
	+1	+1	150
Average for +1	200	90	
Average for -1	40	150	
Main Effect	160	-60	

$$\text{Brake Force}_{\text{Effect}} = \frac{30 + 150}{2} - \frac{50 + 250}{2} = \frac{180}{2} - \frac{300}{2} = 90 - 150 = -60$$

The Main Effect of Brake Force is -60.

$2^k \rightarrow \text{Level}^{\text{Factors}}$

## Main Effects Plots





# Design of Experiments

## General Structure for a Central Composite Design

$2^{n-k}$  Fractional Factorial  
+  
Star points  
+  
Center points

